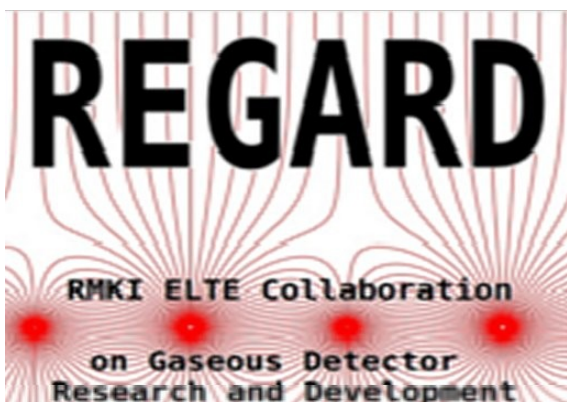


# Development of Micropattern Gaseous Detectors

Investigation of TGEMs as Cherenkov detectors

Gábor Galgóczi

On behalf of the REGARD group of Wigner RCP

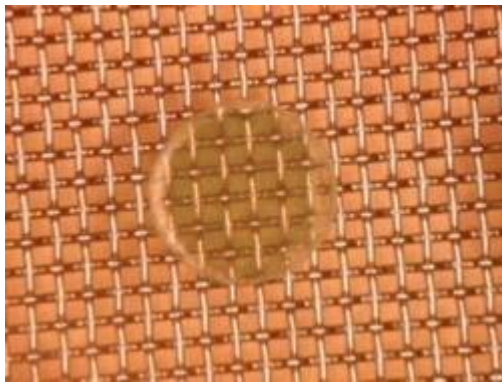


# Outline

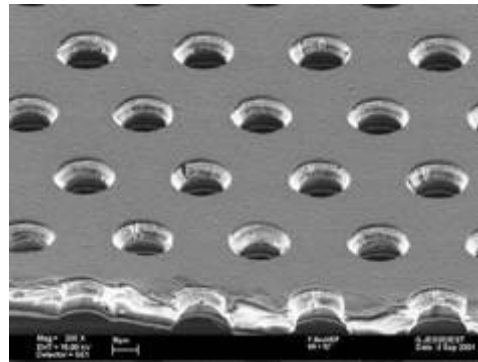
- MPGDs → TGEM (Thick Gas Electron Multiplier)
- Experimental setup
  - Local avalanche size and photoelectron yield
- Measurements:
  - The effect of drift field on the local yield and gain
  - Effects of faults
- AIDA-2020 project
- Summary

# MPGDs

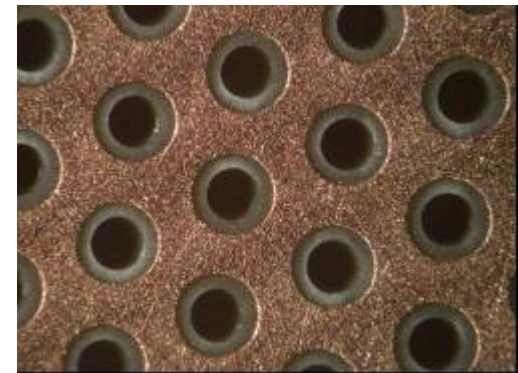
- MicroPattern Gaseous Detectors



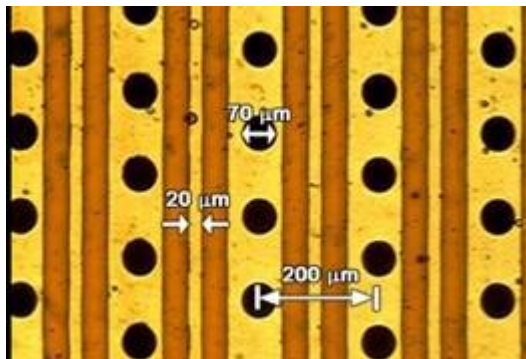
MicroMegas



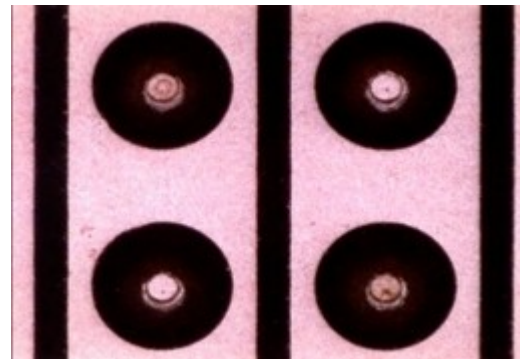
GEM



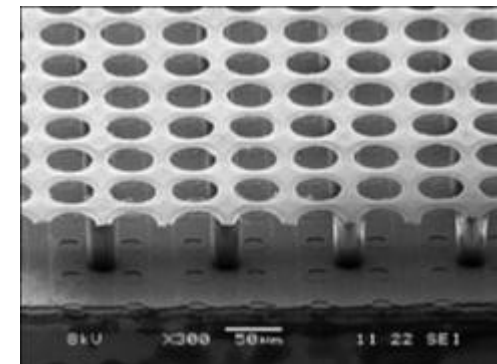
TGEM



MHSP



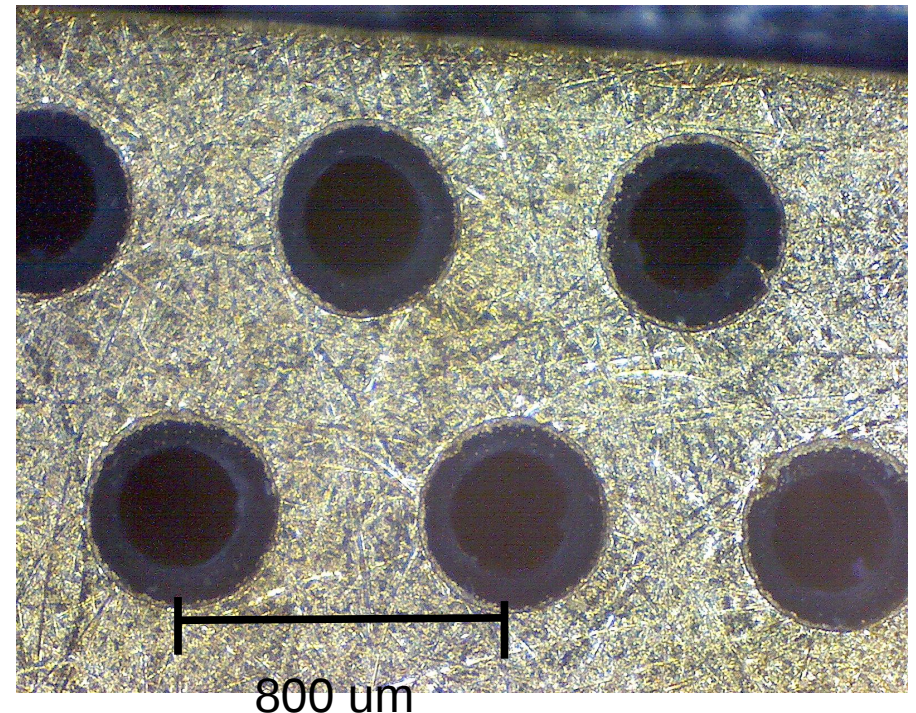
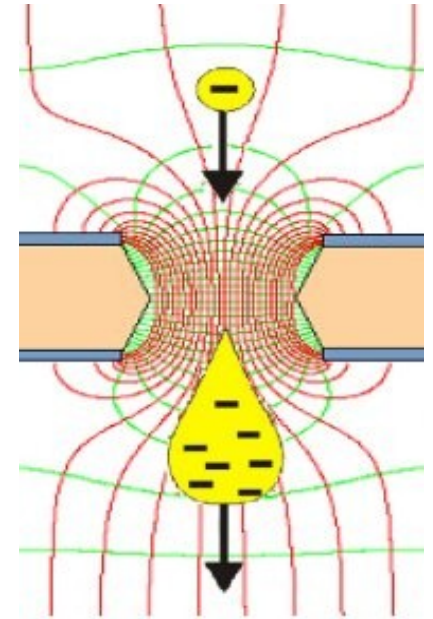
microPIC



Ingrid

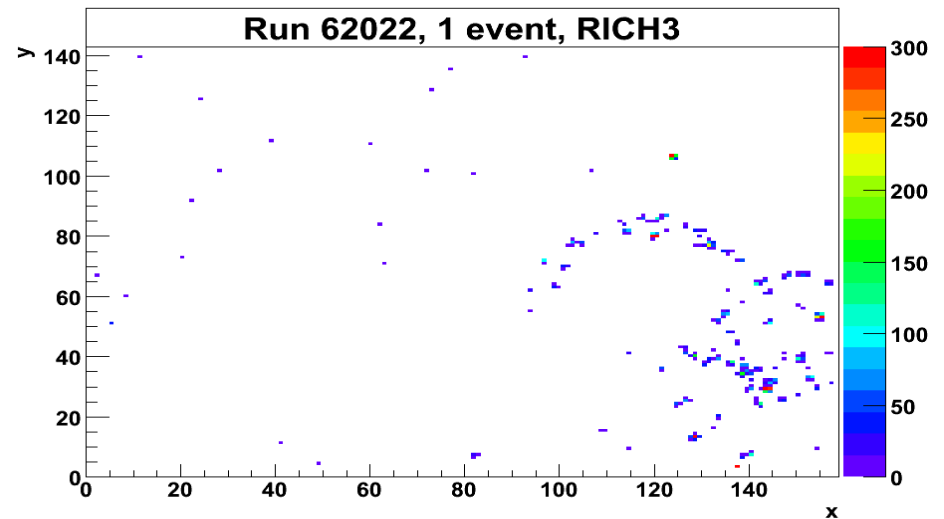
# TGEM

- Thick Gas Electron Multiplier
- Invented in the 2000s
- Hole size: 300-500  $\mu\text{m}$
- Large electric field
- Electron avalanche  
(typical 10-100  $e^-$ )



# TGEMs as photon detectors

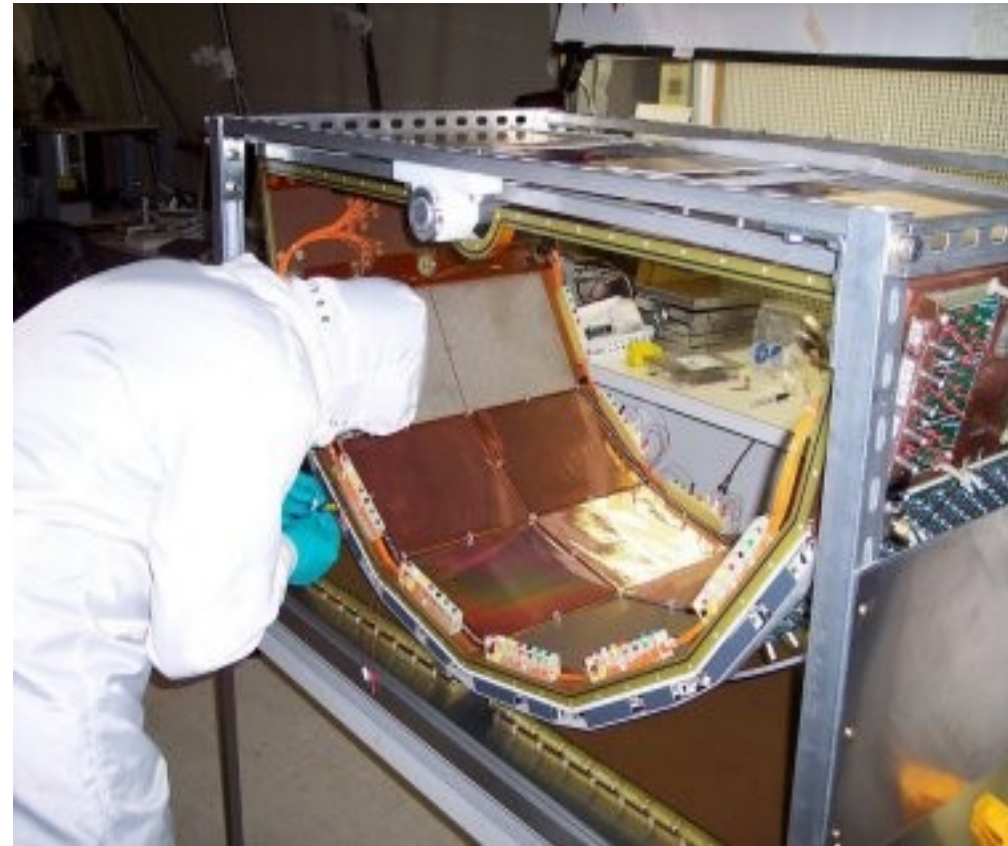
- So far MWPCs (Multi-Wire Proportional Chamber) have been used for Cherenkov photon detection
- TGEMs have many advantages<sup>1</sup>:
  - Direct, faster signal
  - Little secondary signal
  - MIP suppression
  - Reduced ion backflow



<sup>1</sup>V. Peskov, M. Cortesi et al., Further evaluation of a THGEM UV-photon detector for RICH – comparison with MWPC, Journal of Instrumentation, vol. 5 page 11004-11029, 2010

# TGEMs in experiments as Cherenkov detectors

- So far (GEM):
  - HBD at PHENIX (RHIC)
- Plans (TGEM):
  - VHMPID at ALICE (LHC)
  - RICH-1-Upgrade at COMPASS (SPS)

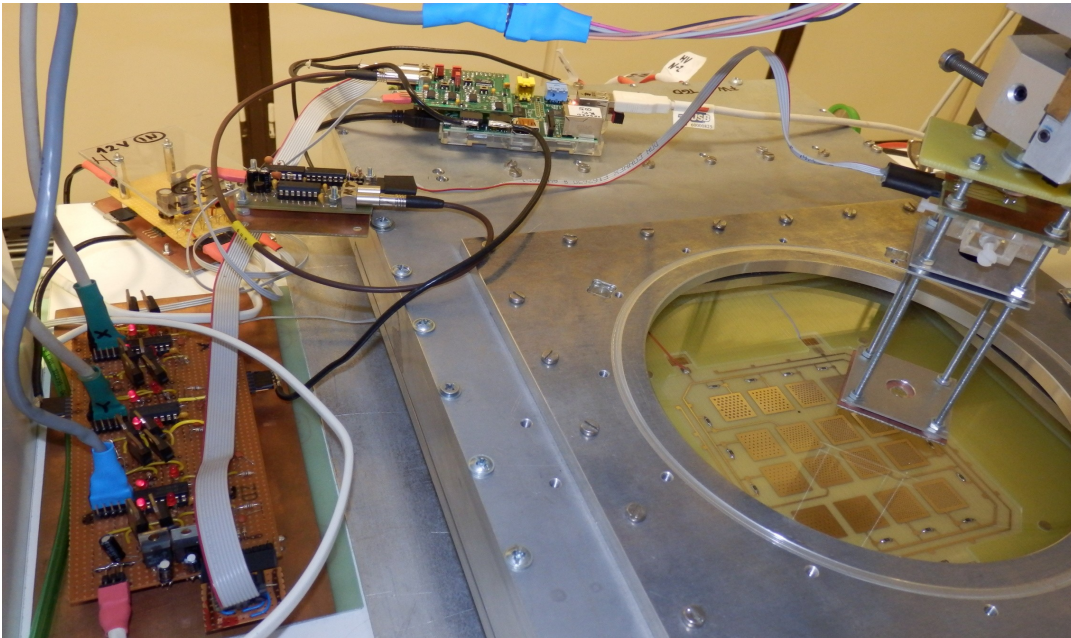


Hadron Blind Detector, PHENIX

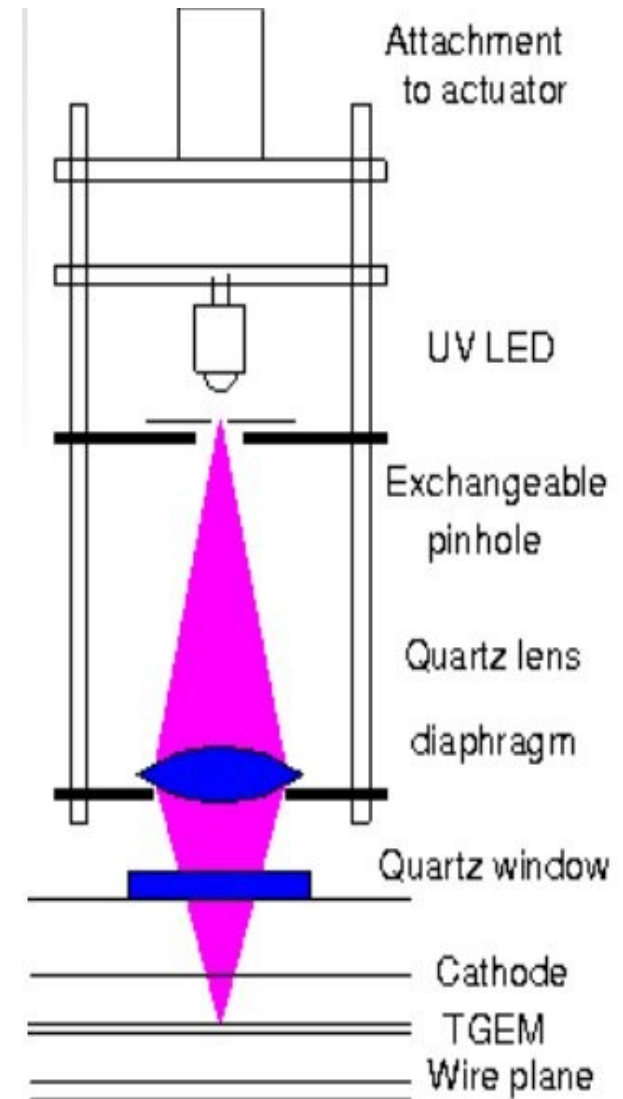
# Aims

- Precise description of microprocesses of single photo-electron detection in MPGDs
- **Optimization of geometrical parameters of TGEMs for Cherenkov applications (hole diameter, pitch, rim, thickness, lattice shape)**
- **Optimization of electric field configurations (amplification, drift, extraction)**
- Microscale measurements for finetuning the simulation codes
- Identify effect of production faults (over etching, drilling faults, etc. )

# Experimental setup



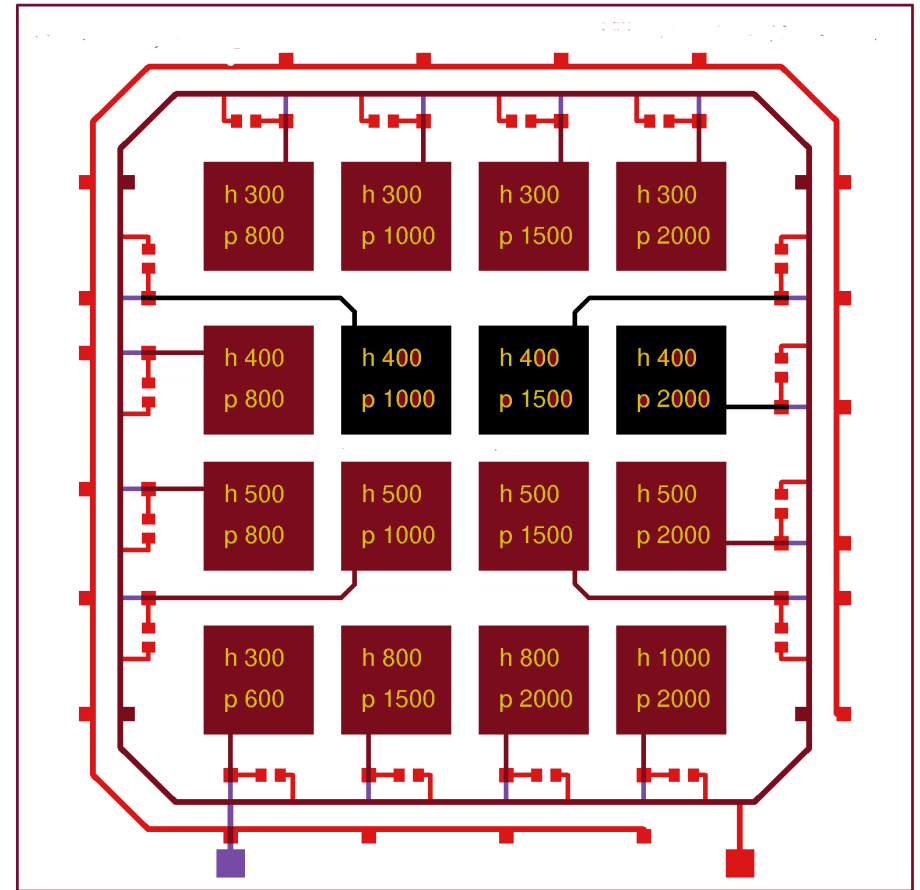
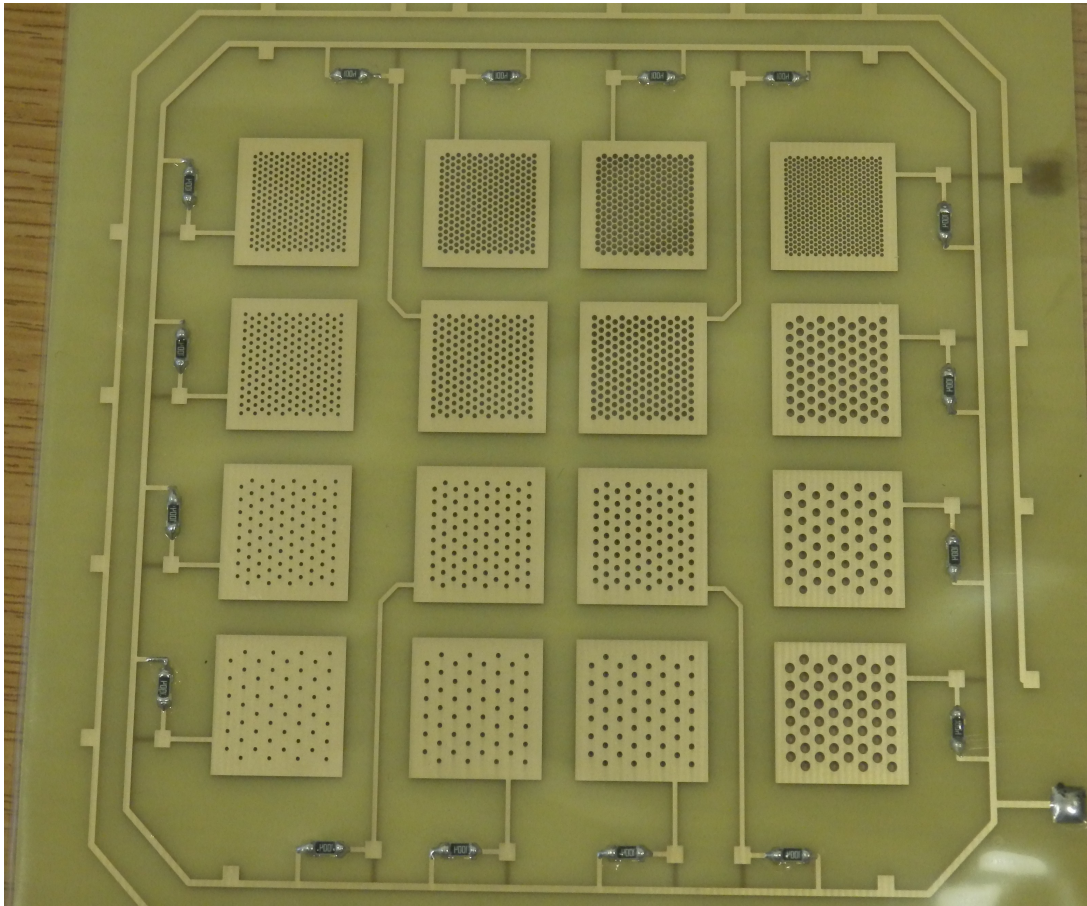
- New method for single photoelectron measurement<sup>2</sup>
- REGARD & RD51 collaboration
- Pulsed LED driven with 100 kHz
- 50  $\mu\text{m}$  resolution



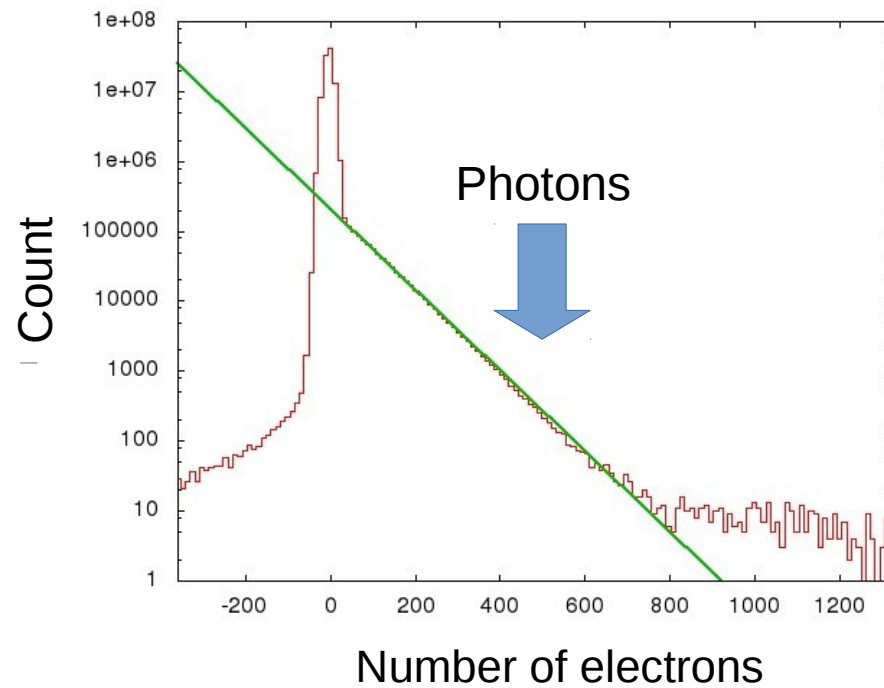
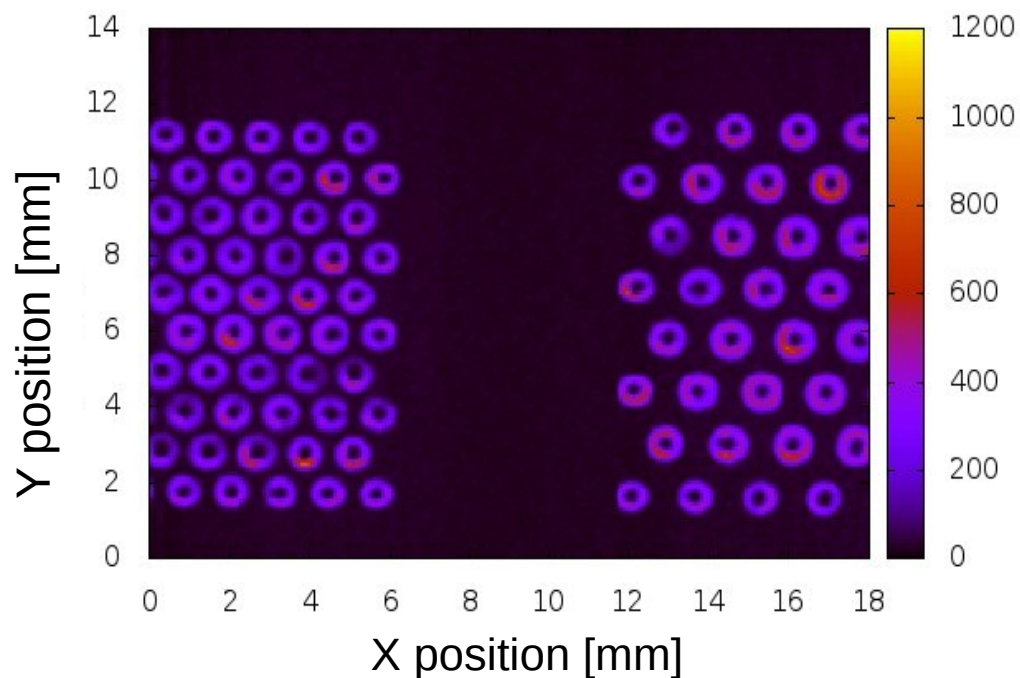
<sup>2</sup>High resolution surface scanning of Thick-GEM for single photo-electron detection, G. Hamar, D. Varga, NIM A<sup>8</sup> 694, p 16-23, 2012 Gábor Galgóczi – Development of Micropattern Gaseous Detectors



# Experimental setup

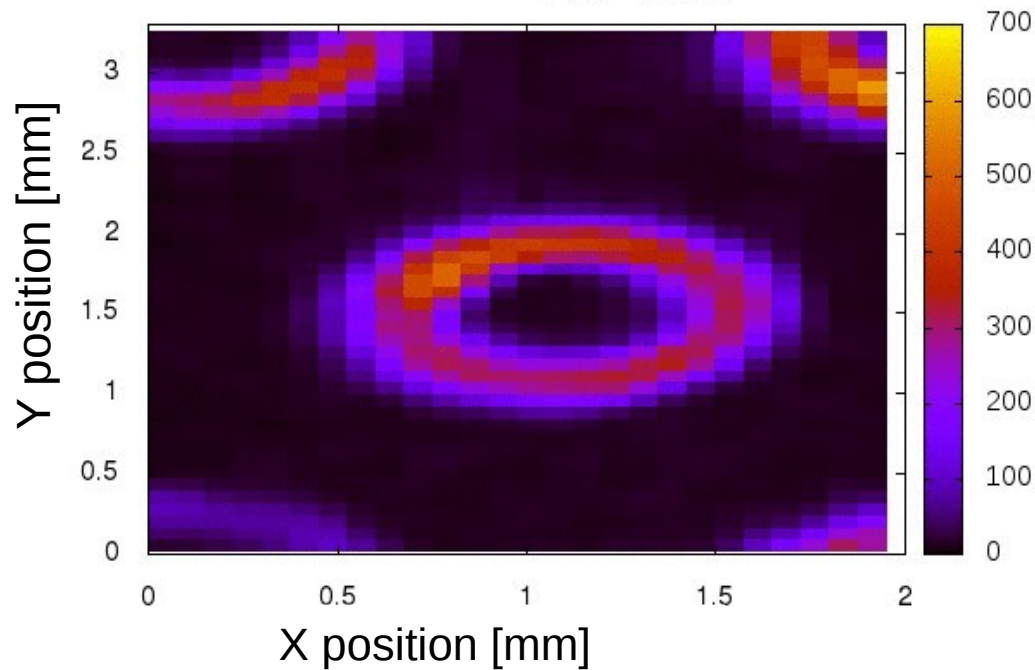


# Photoelectron yield maps

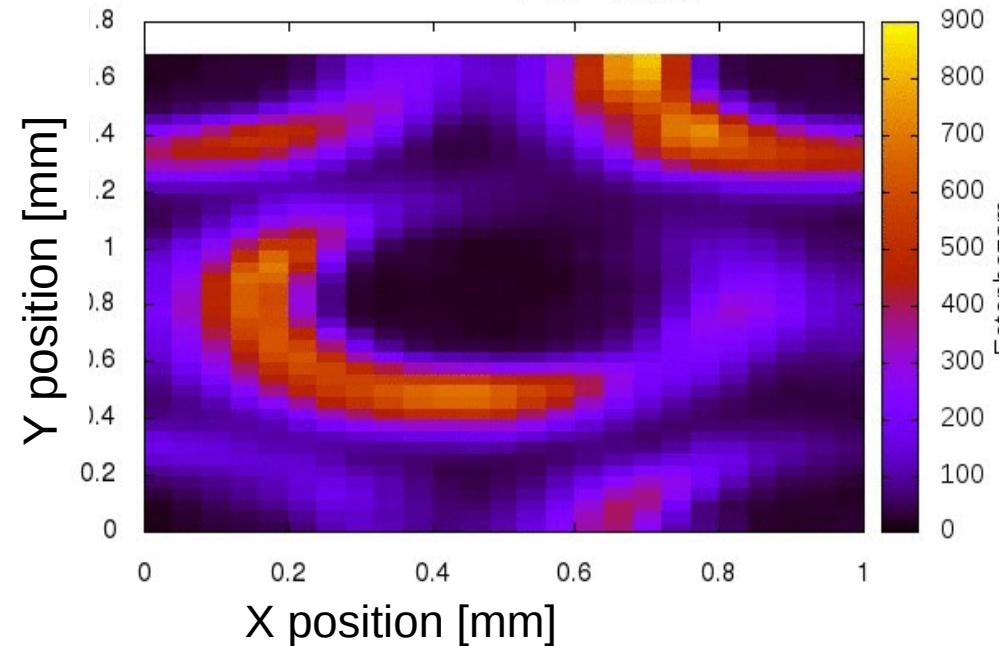


# Different drift fields

Hole distance of 2 mm  
-787 V/cm

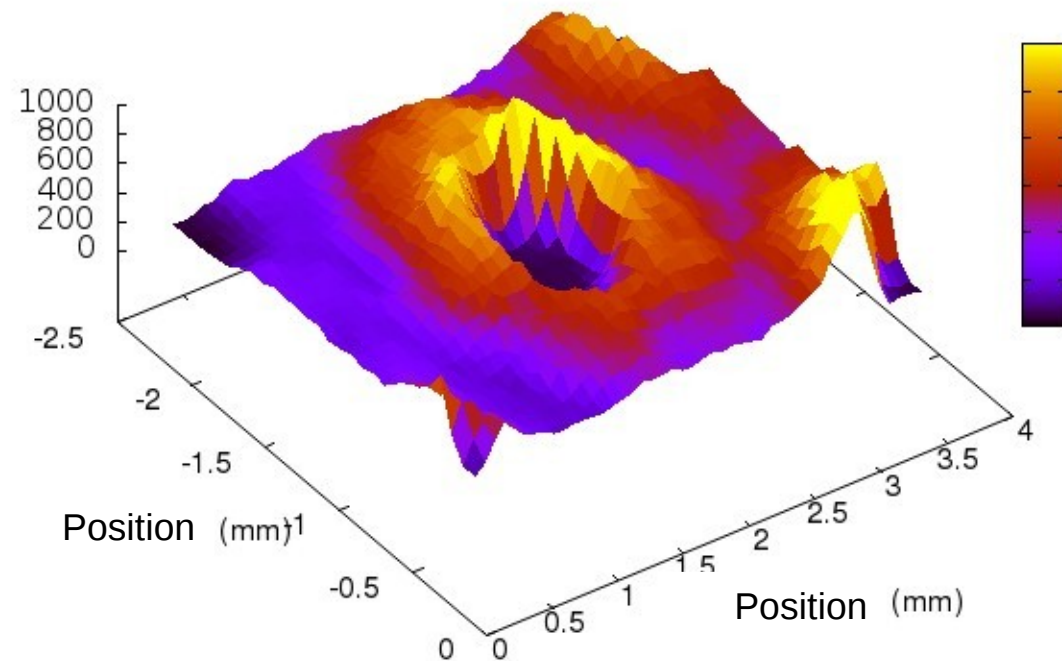
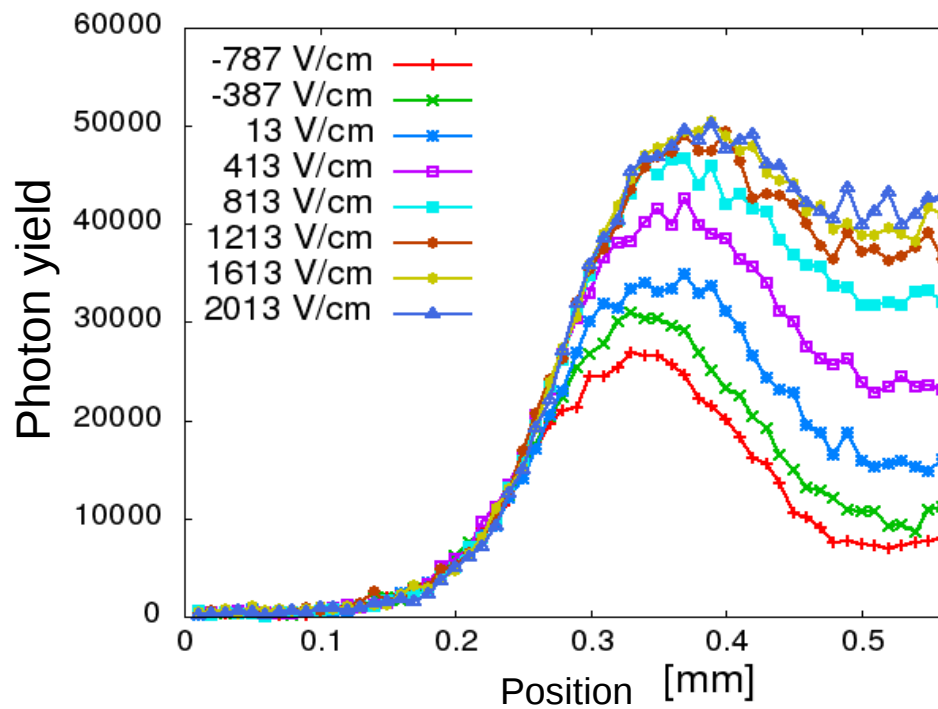


Hole distance of 1 mm  
-787 V/cm

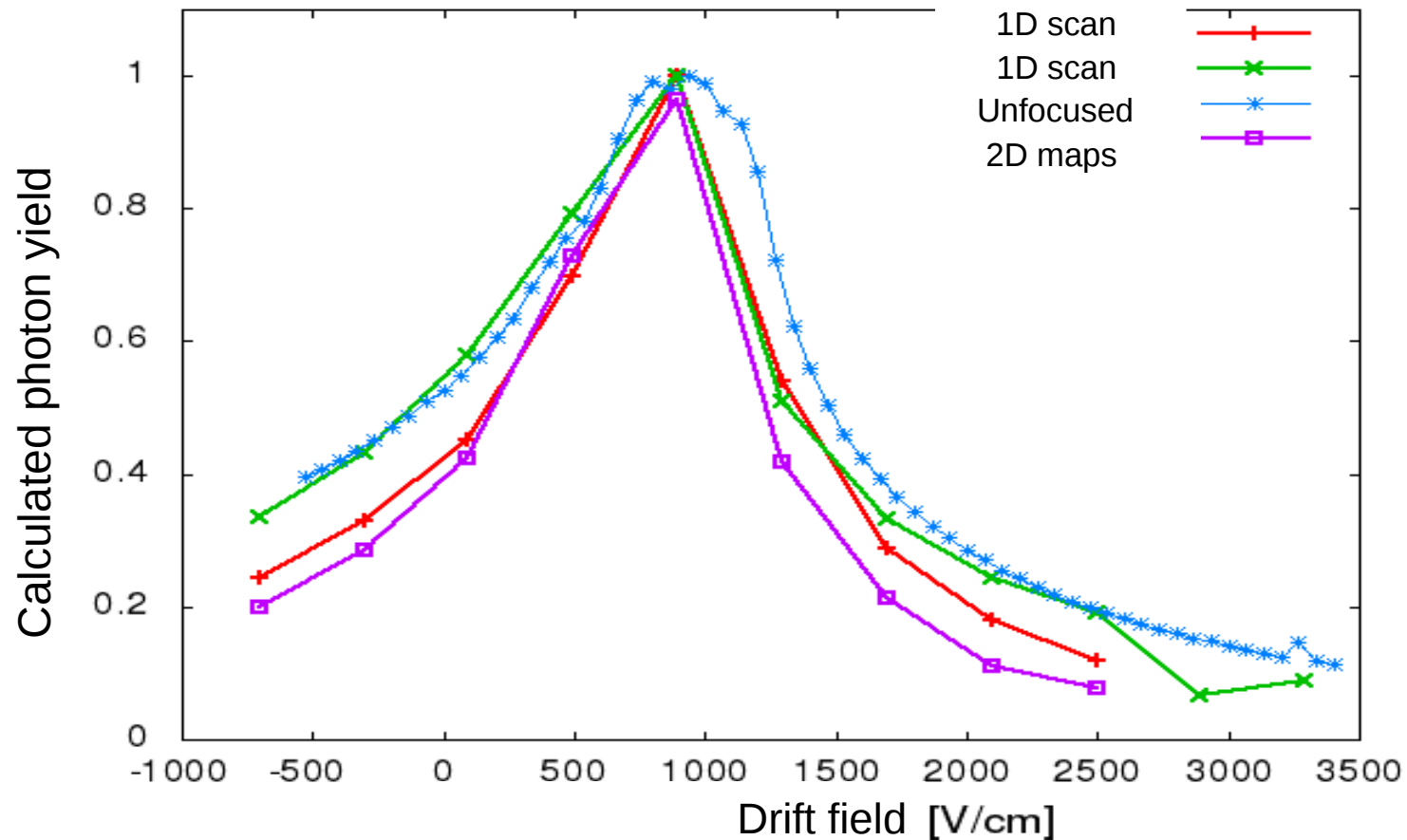


- Field of TGEM holes  $\leftrightarrow$  Drift field
- Integrated photon yield of each hole

# Photon yield



# Correlation of different methods

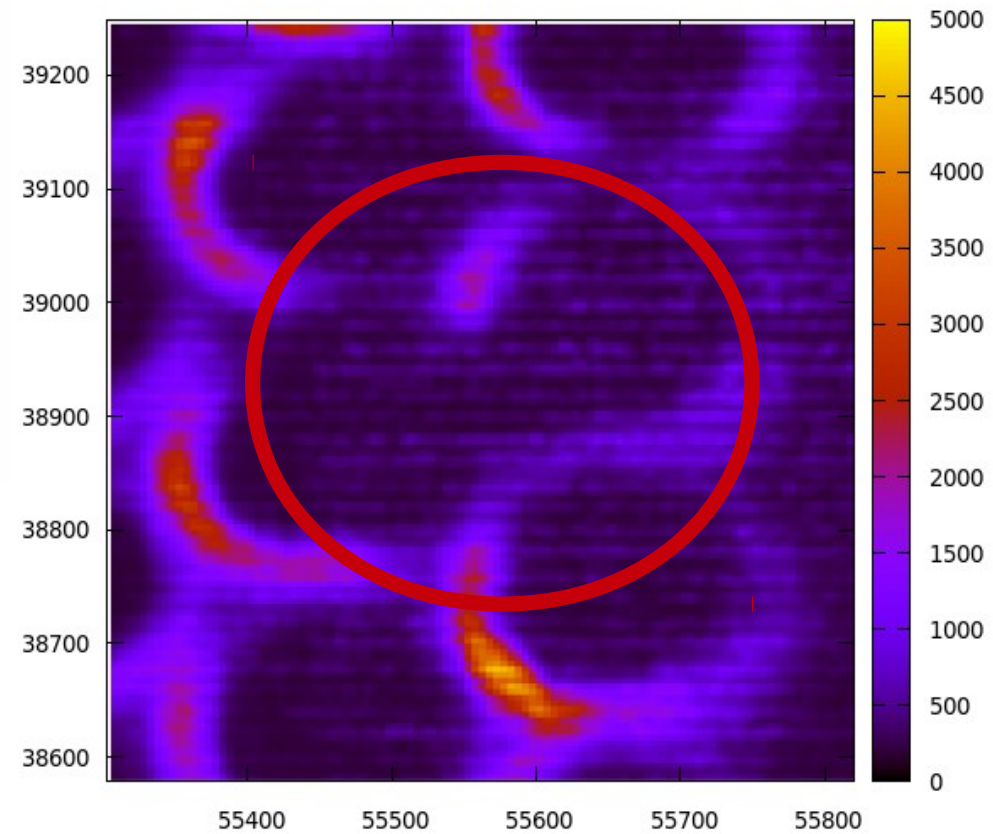
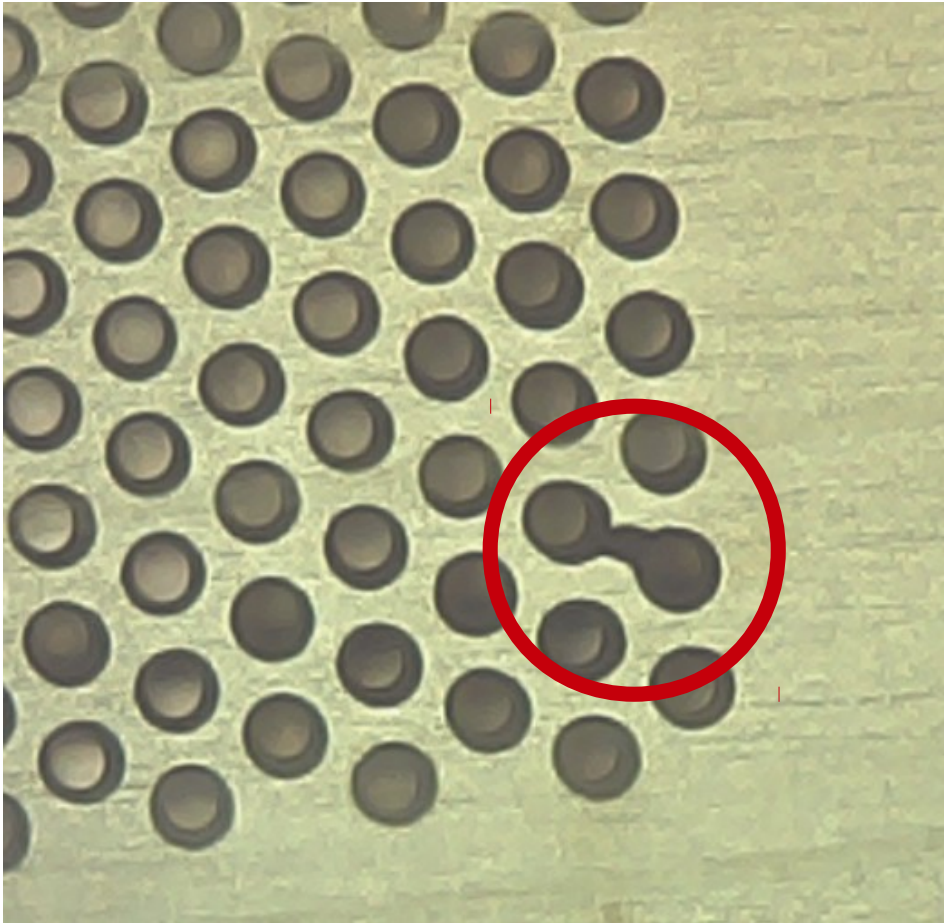


- Different methods → Correlate
- Optimal drift field

# Effects of faults

- Typical GEM: 1000? holes
- Leopard was upgraded with a microscope
- Faults spotted by microscope
- Examined by Leopard
- Which kind of faults would lead to malfunction?

# Effects of faults



Yield map

# Outlook: AIDA-2020 project

- Advanced European Infrastructures for Detectors at Accelerators
- Joint Research Activities:
  - “R&D with emphasis on detector qualification, on quality insurance and on infrastructures leading towards large scale production”
- Quality control tool for detailed (hole by hole) gain maps in (T)GEM-s
- AIDA-2020 Sub-task 13.4.4 (WP13)



# Summary

- TGEM technology
- Remotely controllable system to study (T)GEMs
- High resolution gain and photoelectron scanning
- Drift field
- AIDA-2020
- R&D:
  - Optimazition
  - Quality assurance

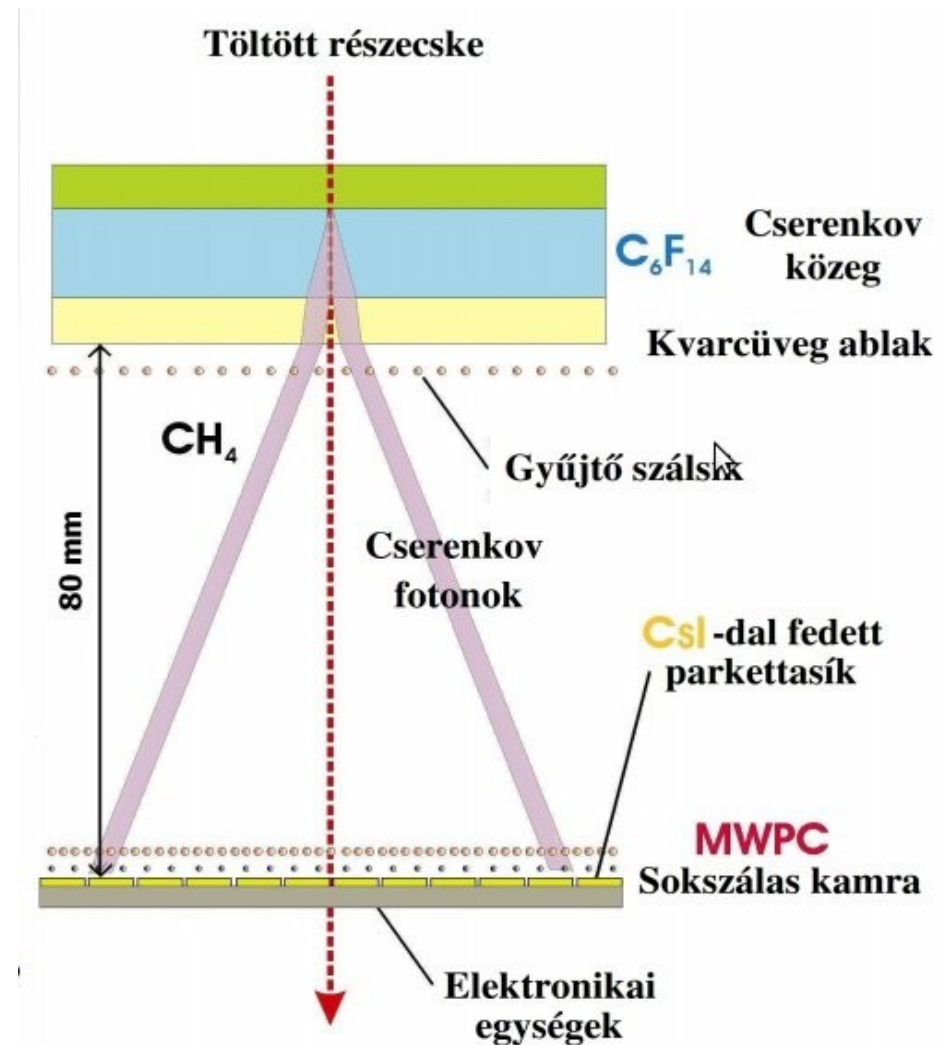
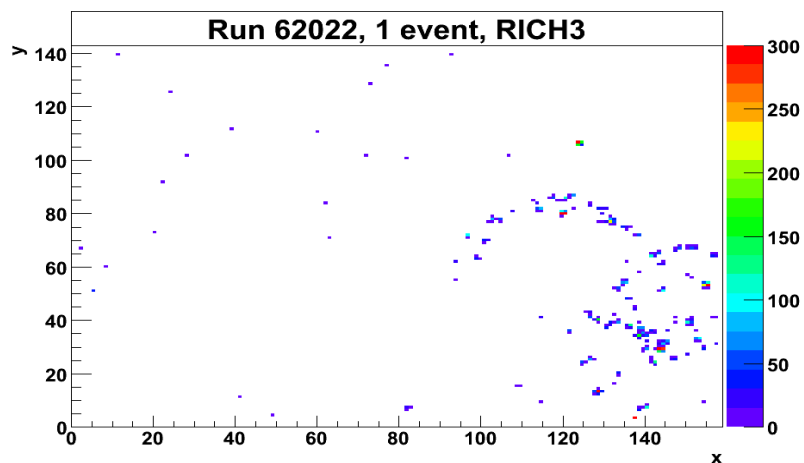
Thank you for your attention!

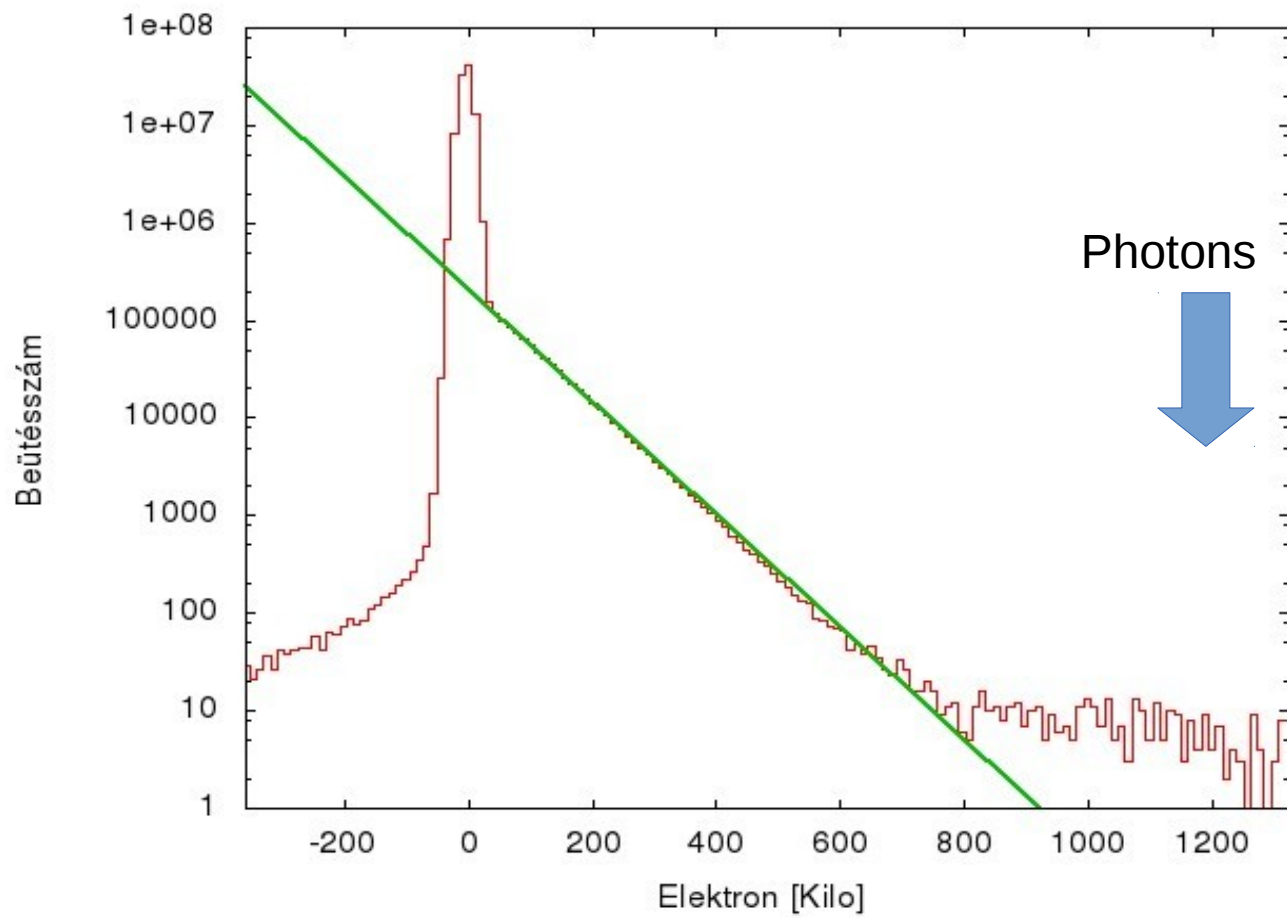
# Backup slides



# PID

$$\cos \varphi = \frac{c}{nv} = \frac{c'}{v}$$

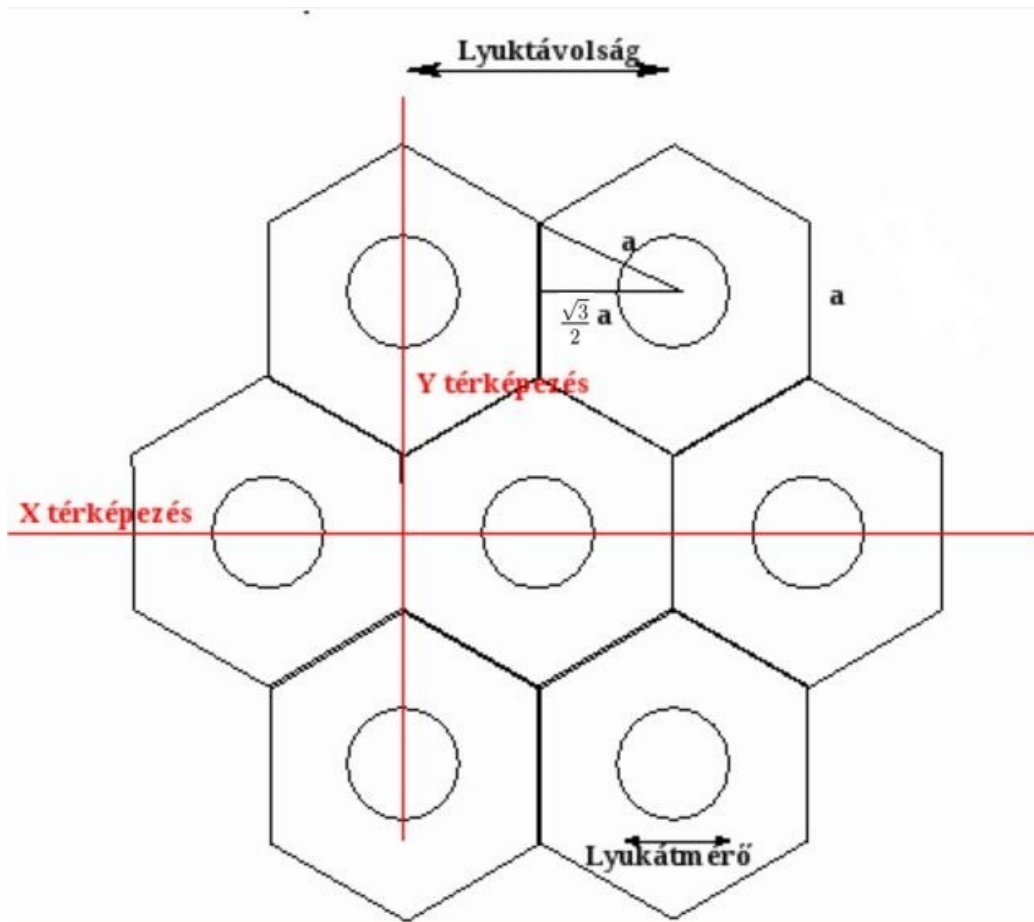




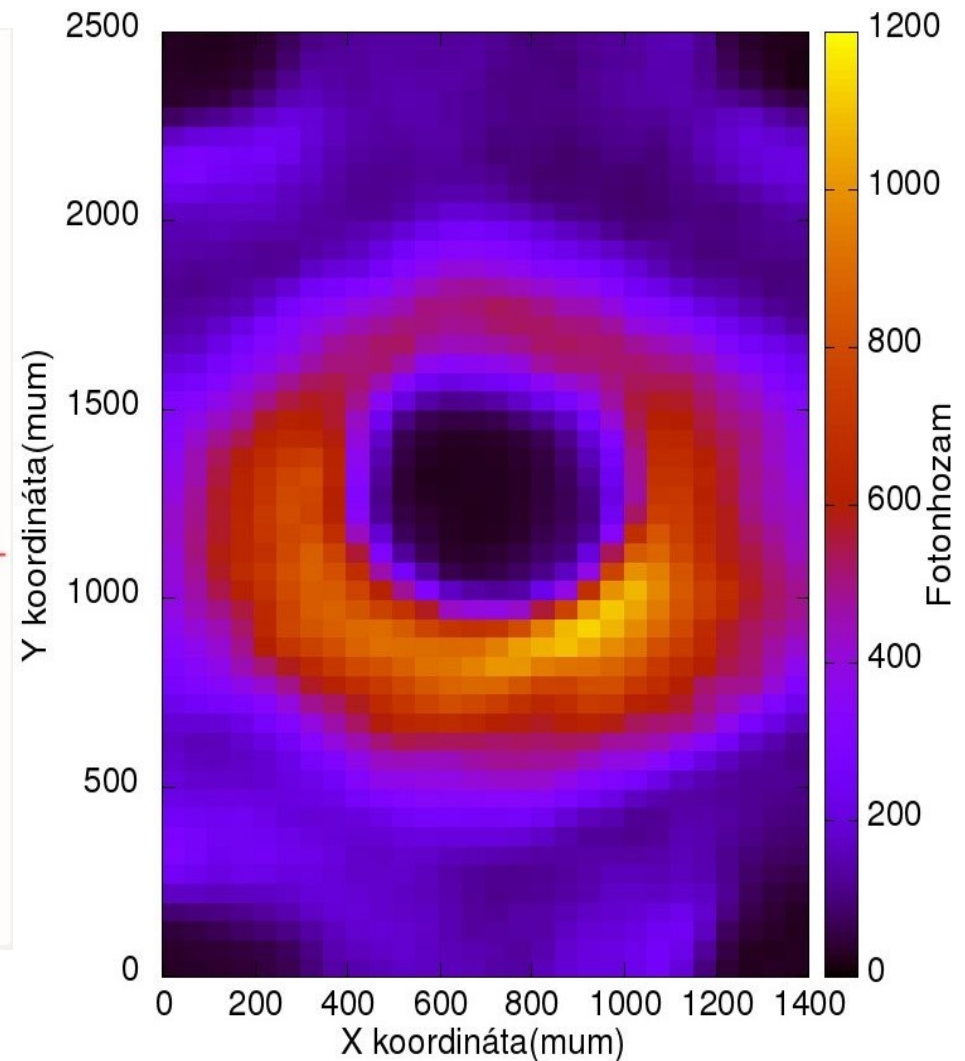
100 million

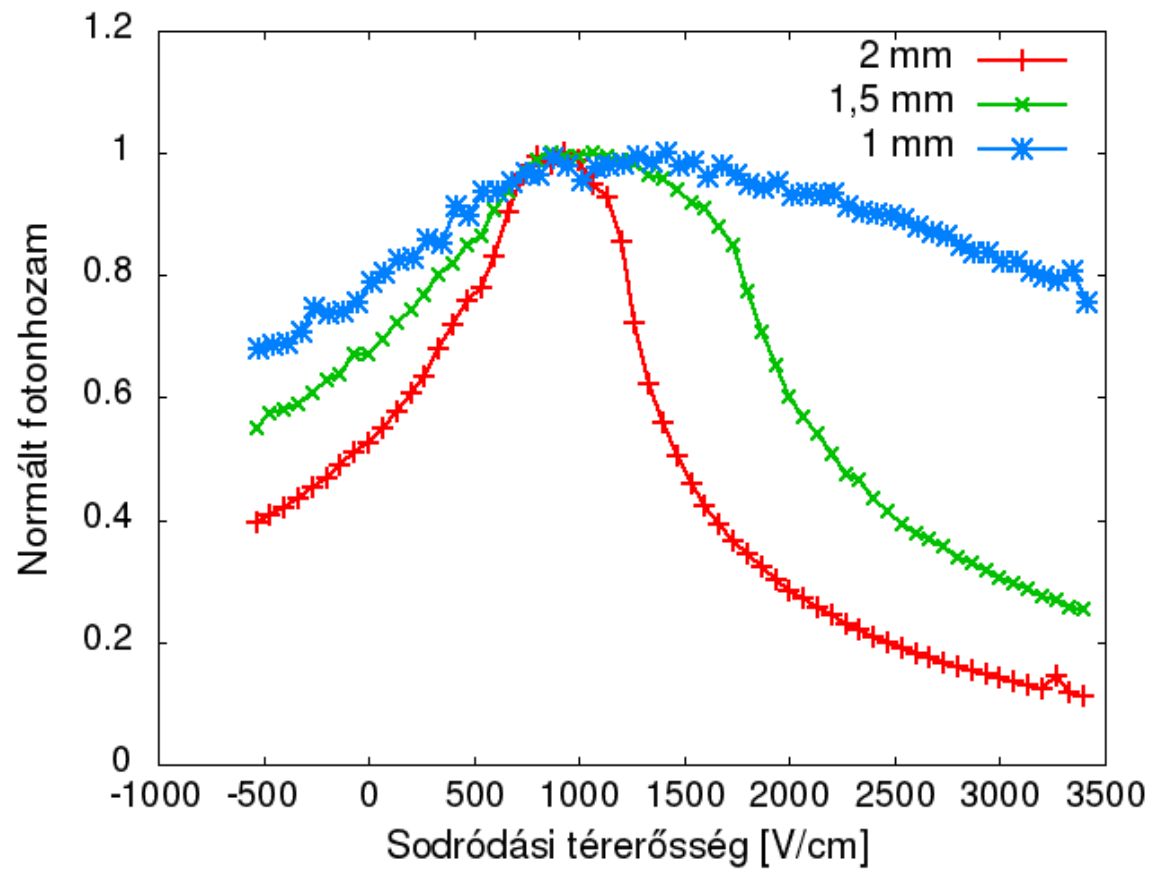
# Examination of individual holes

1D scan

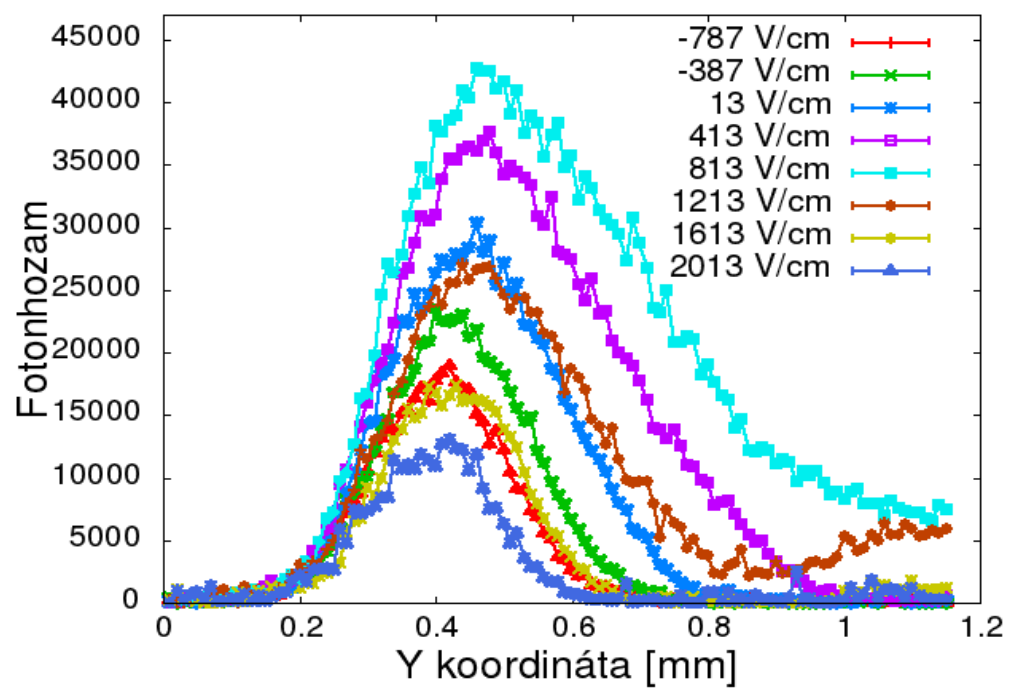
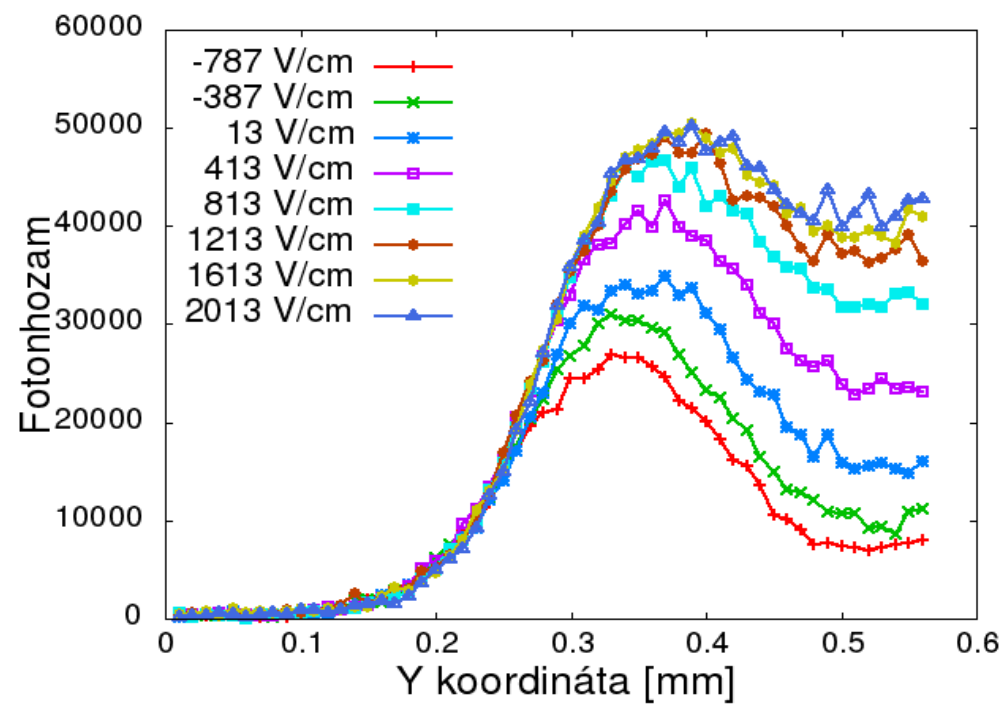
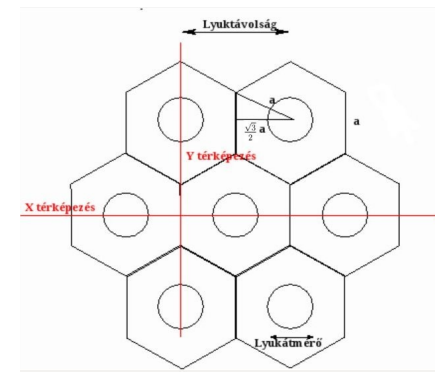
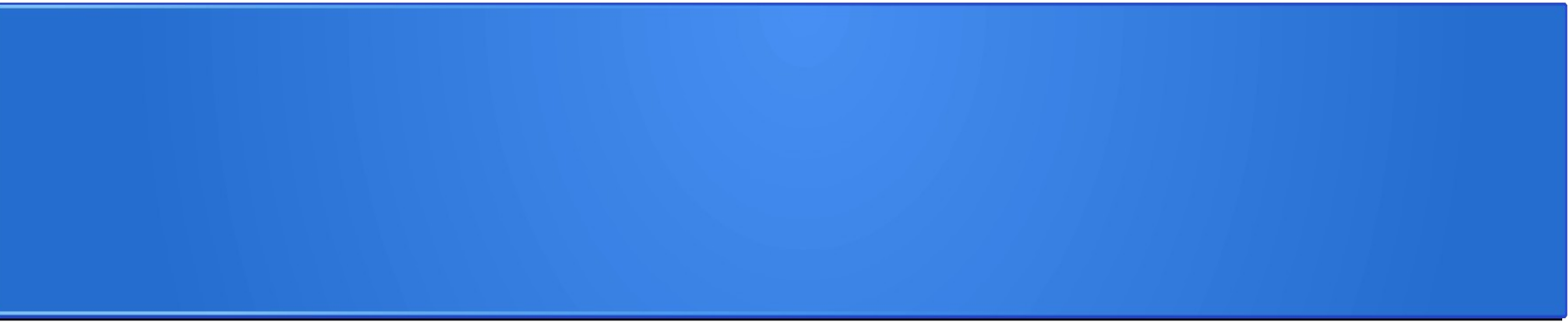


2D maps

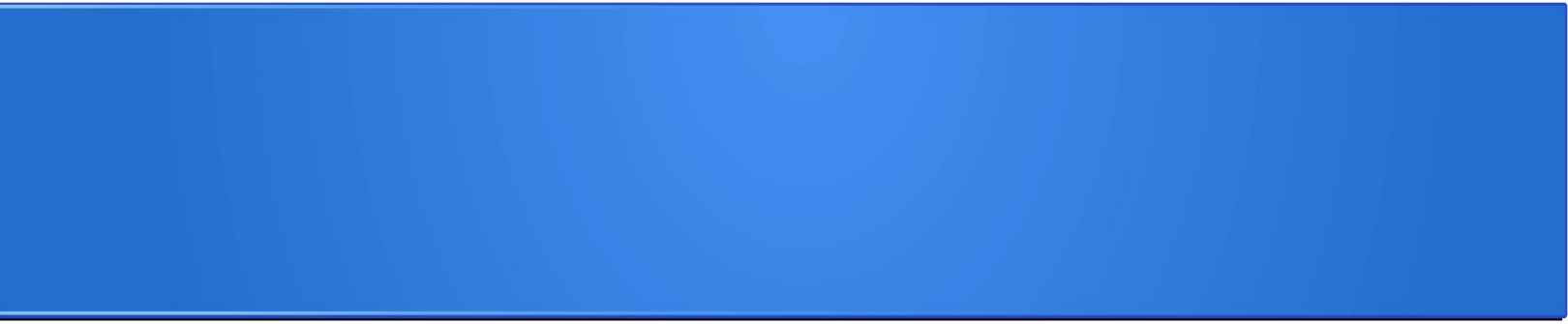




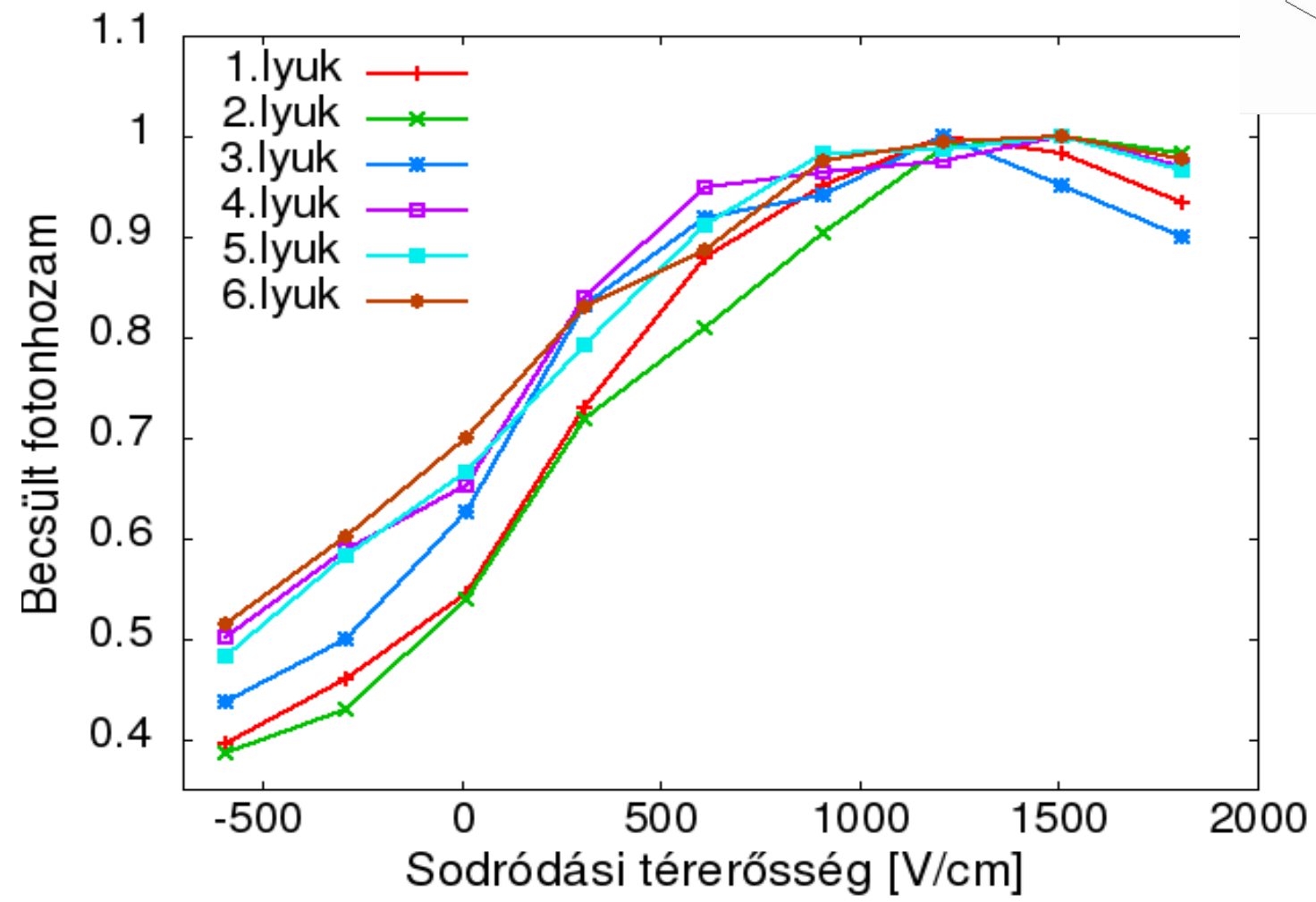
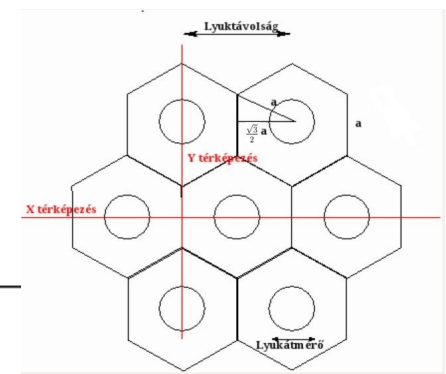
0,4

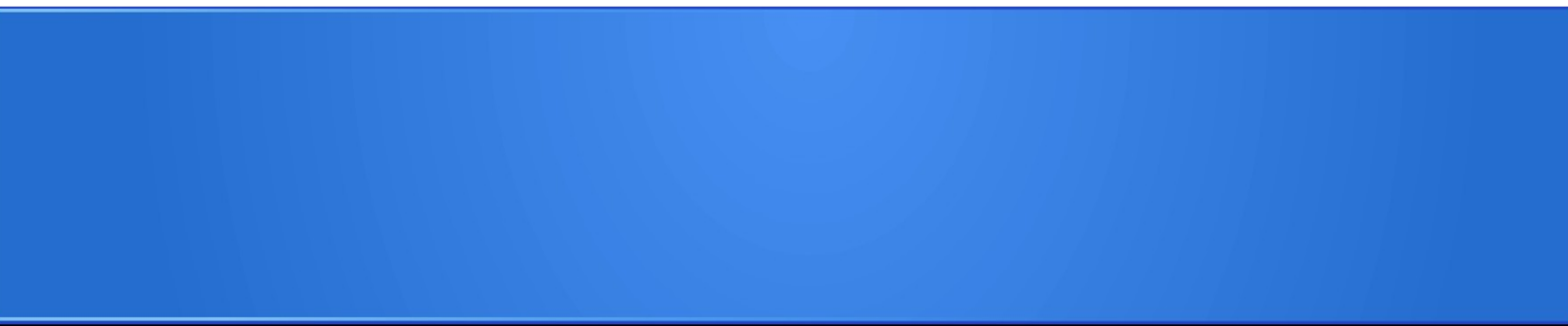




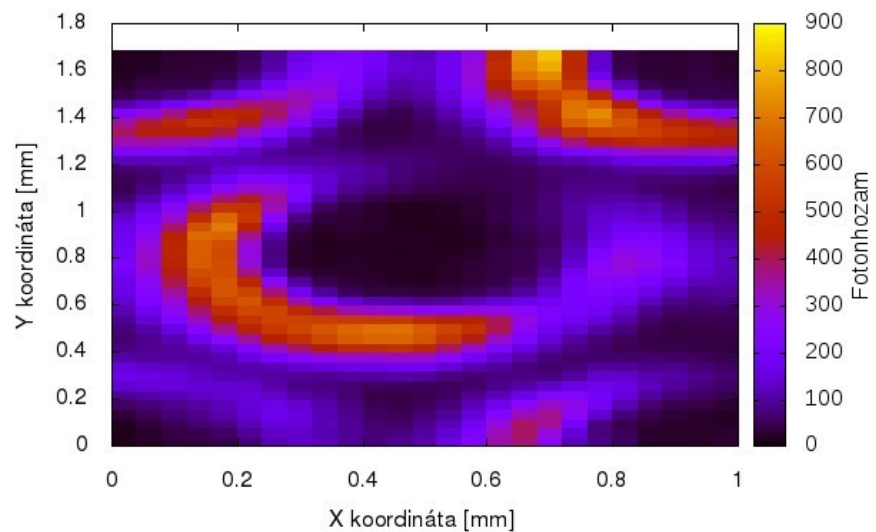


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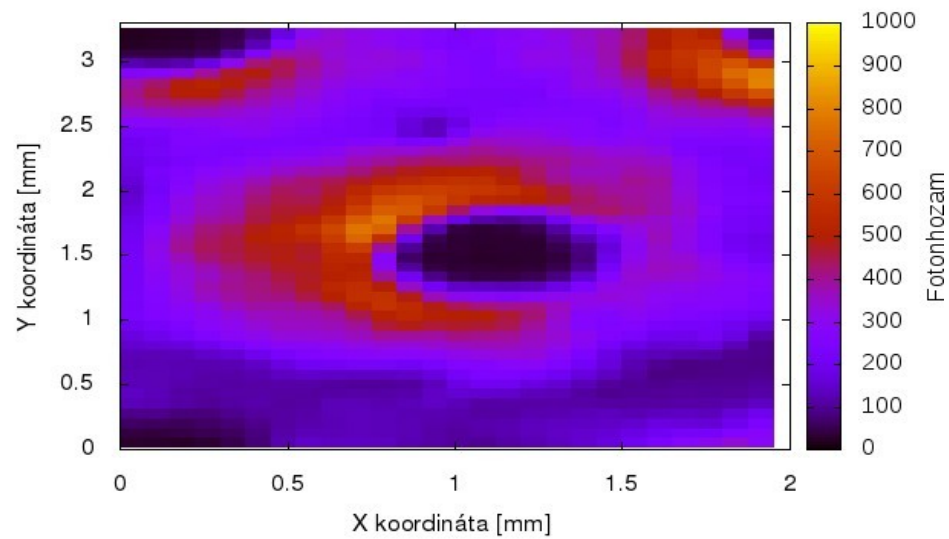
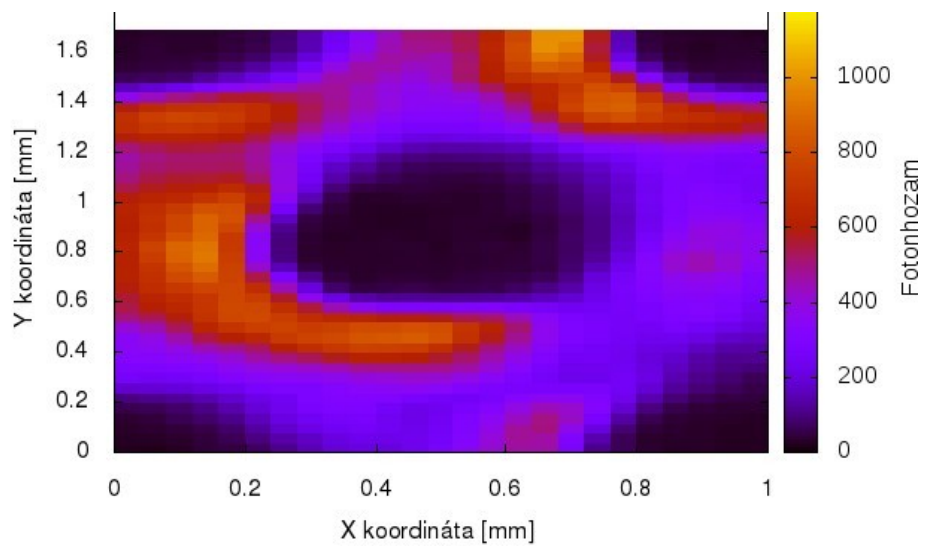
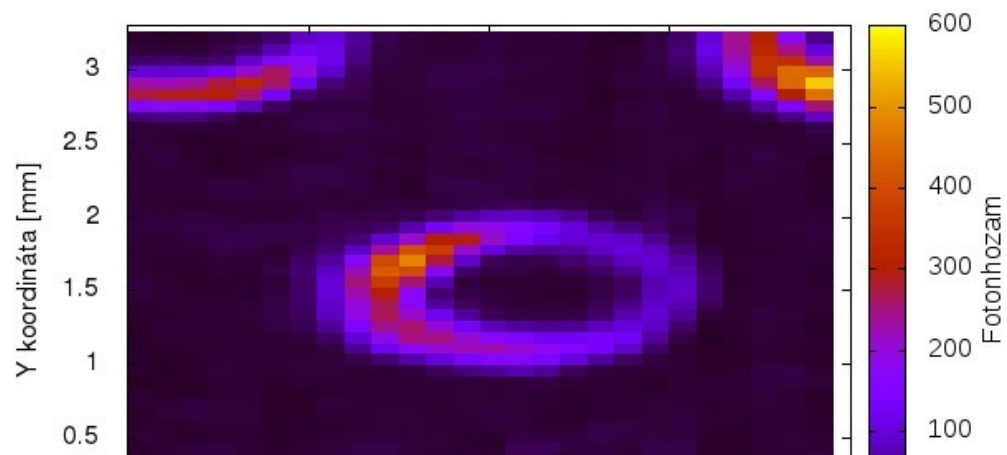


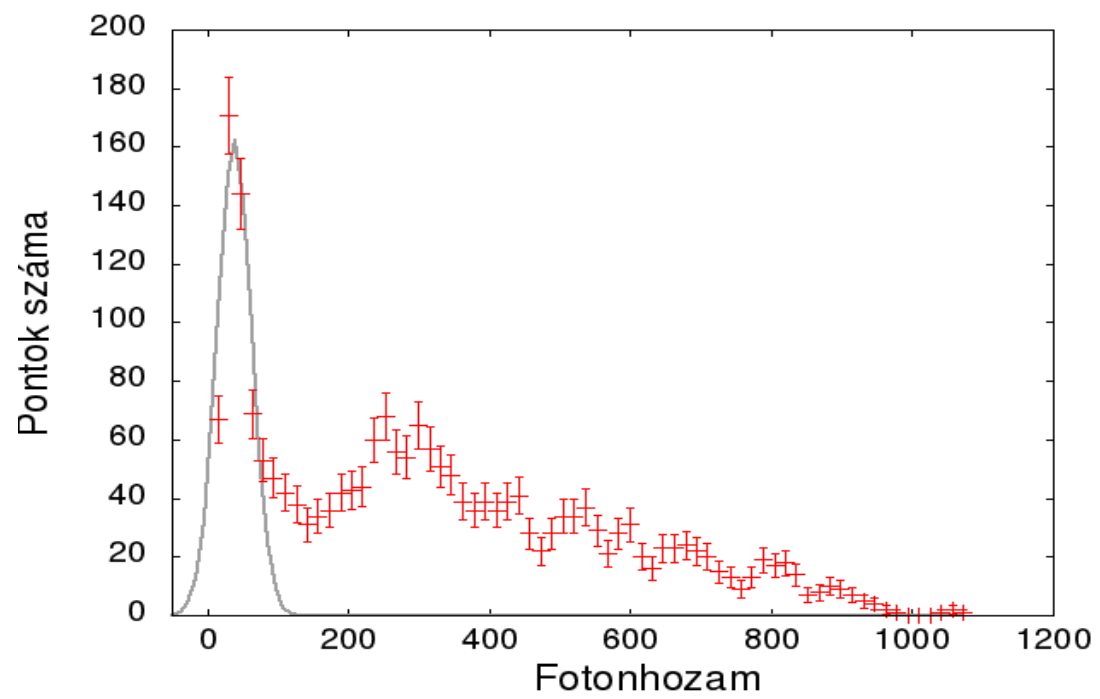
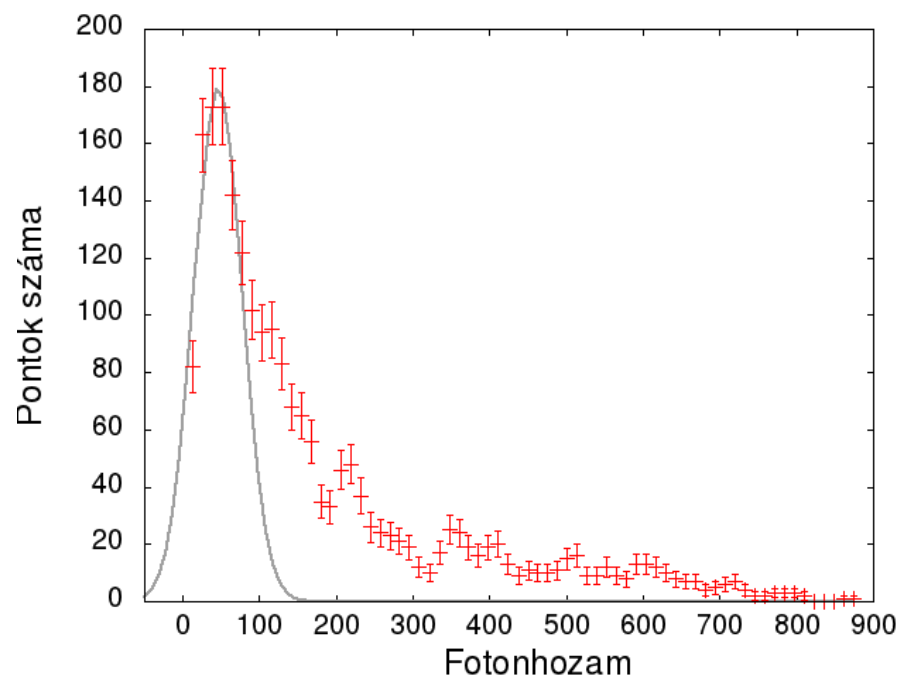


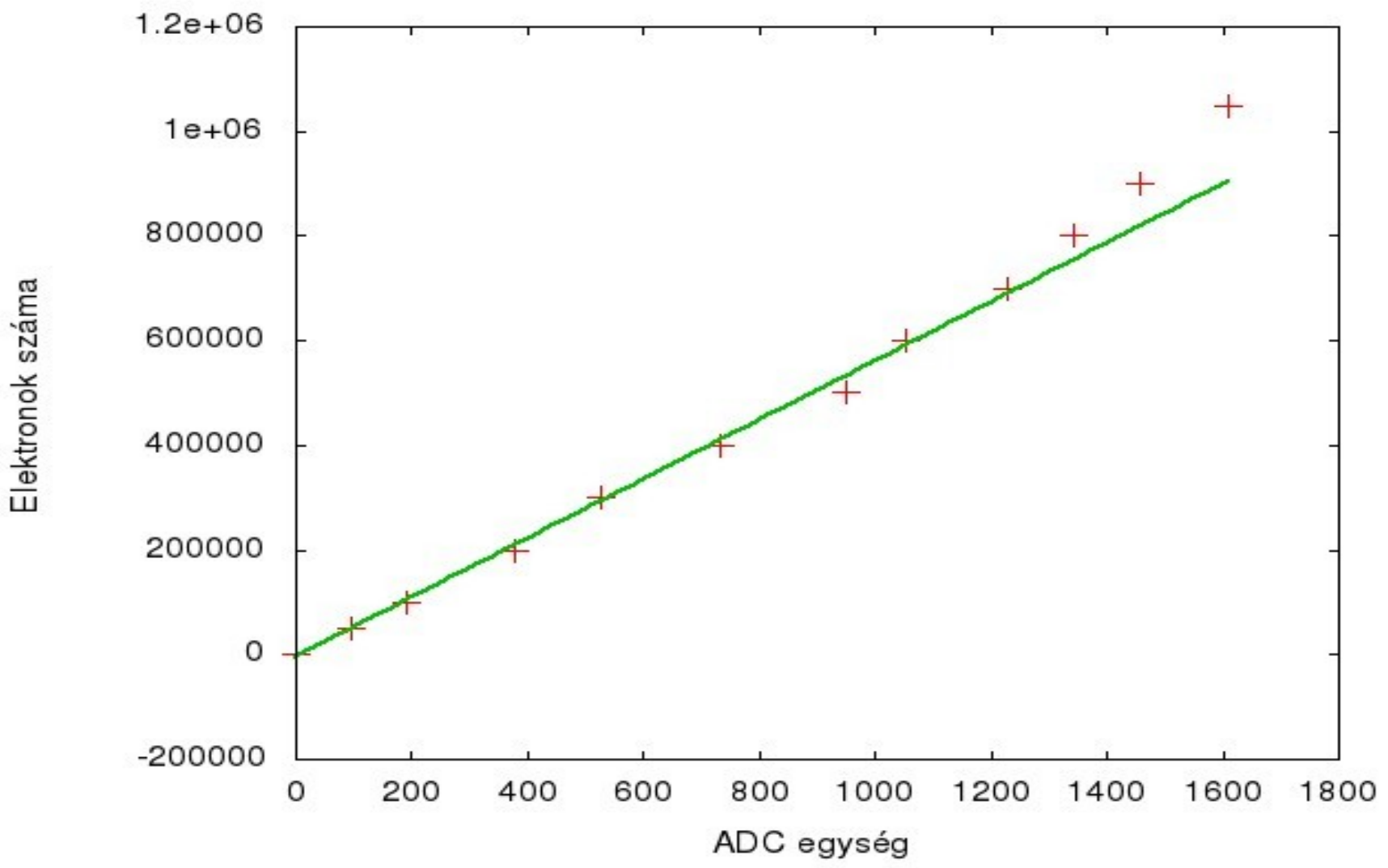
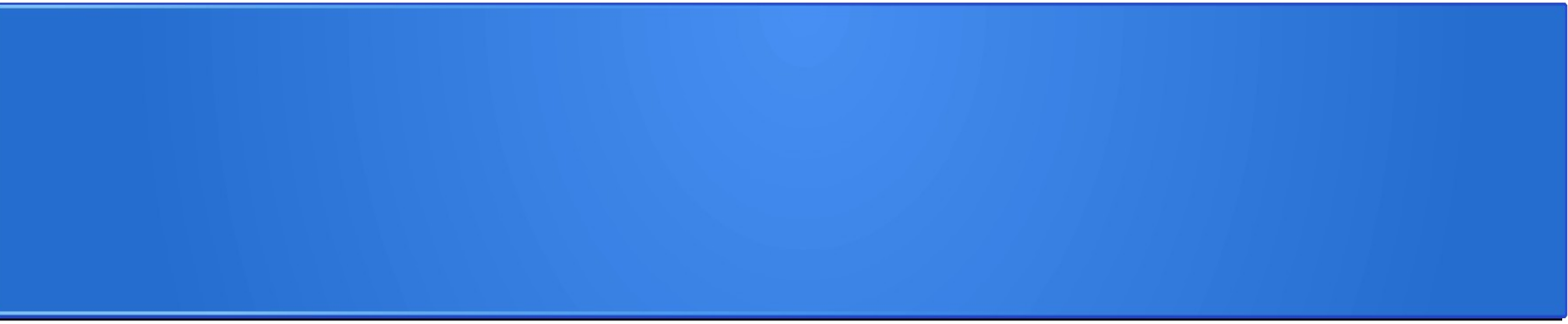
1 mm

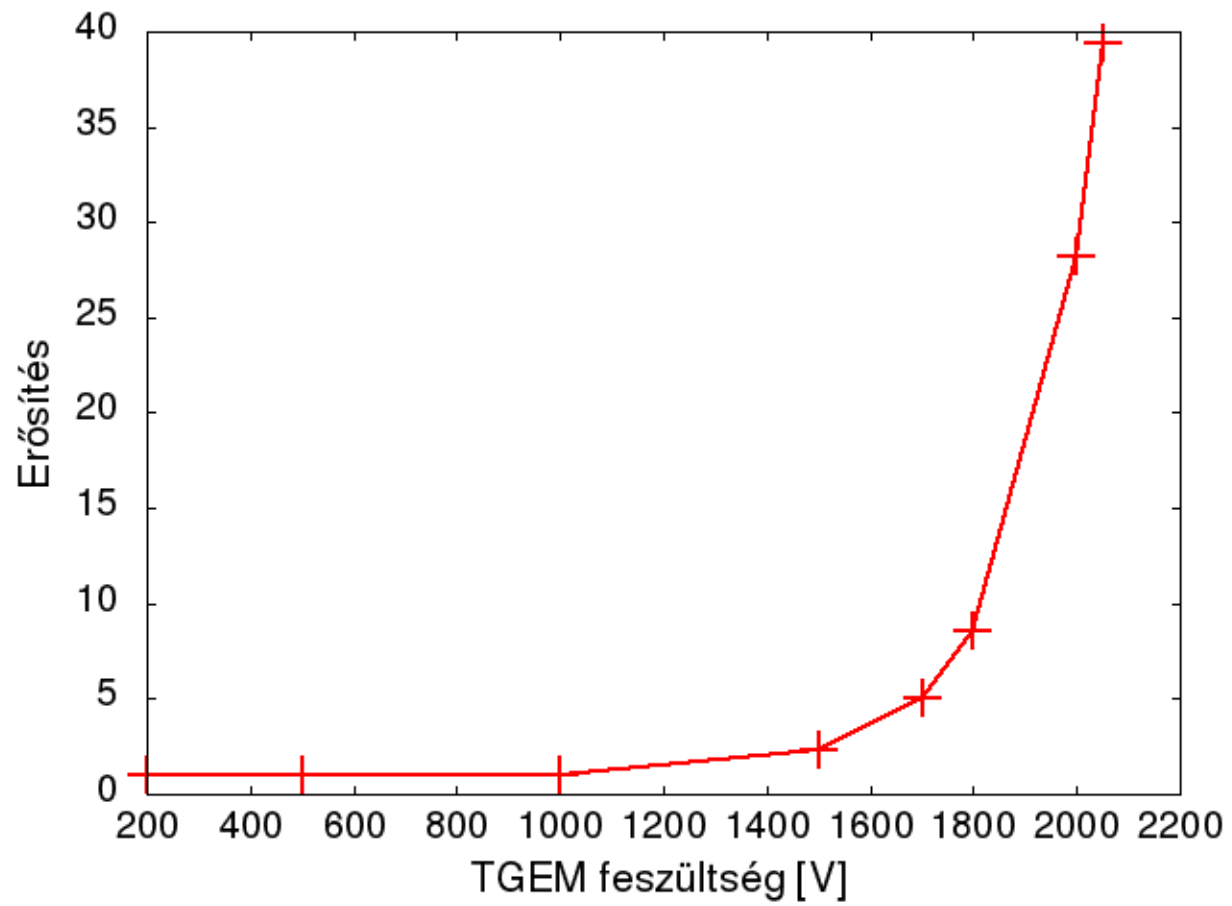


2 mm

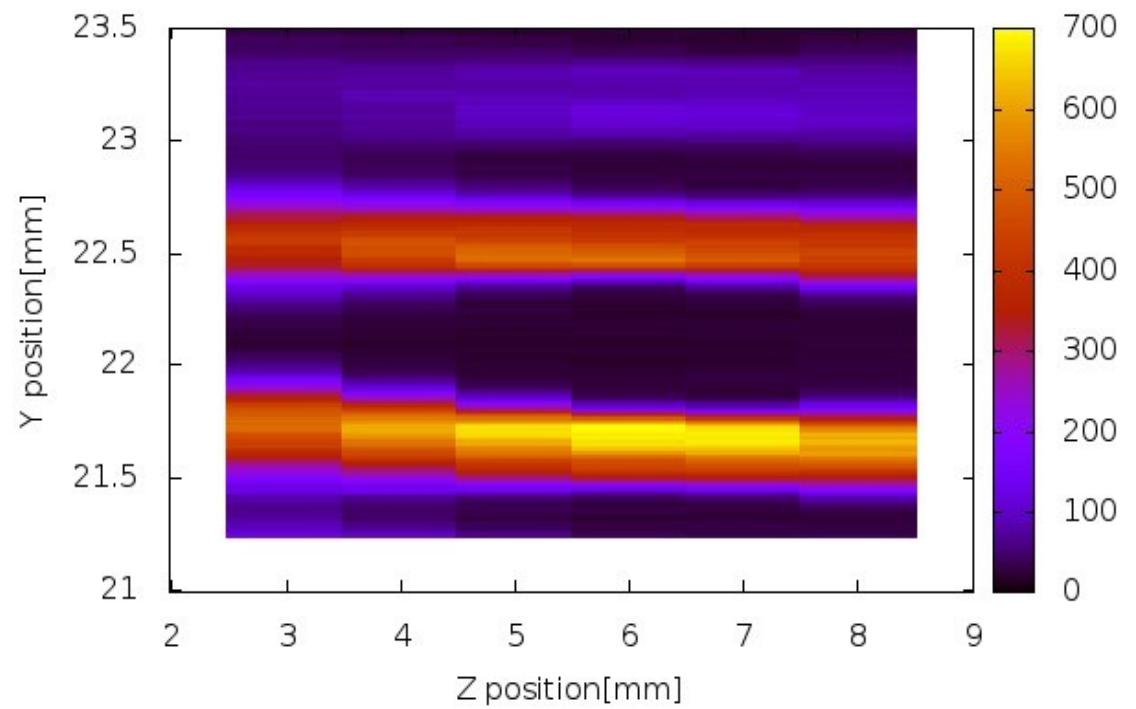
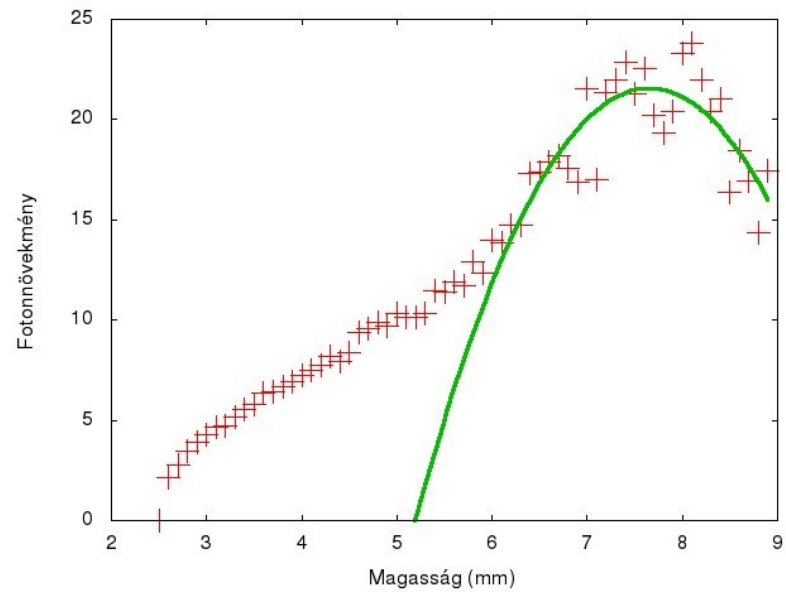
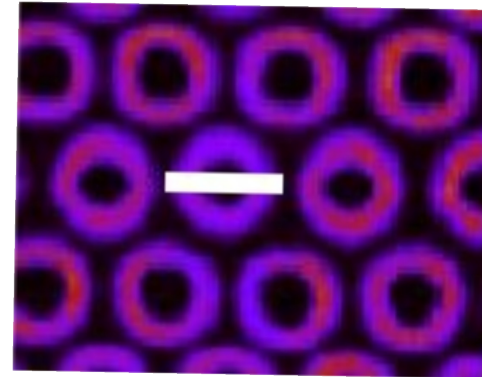


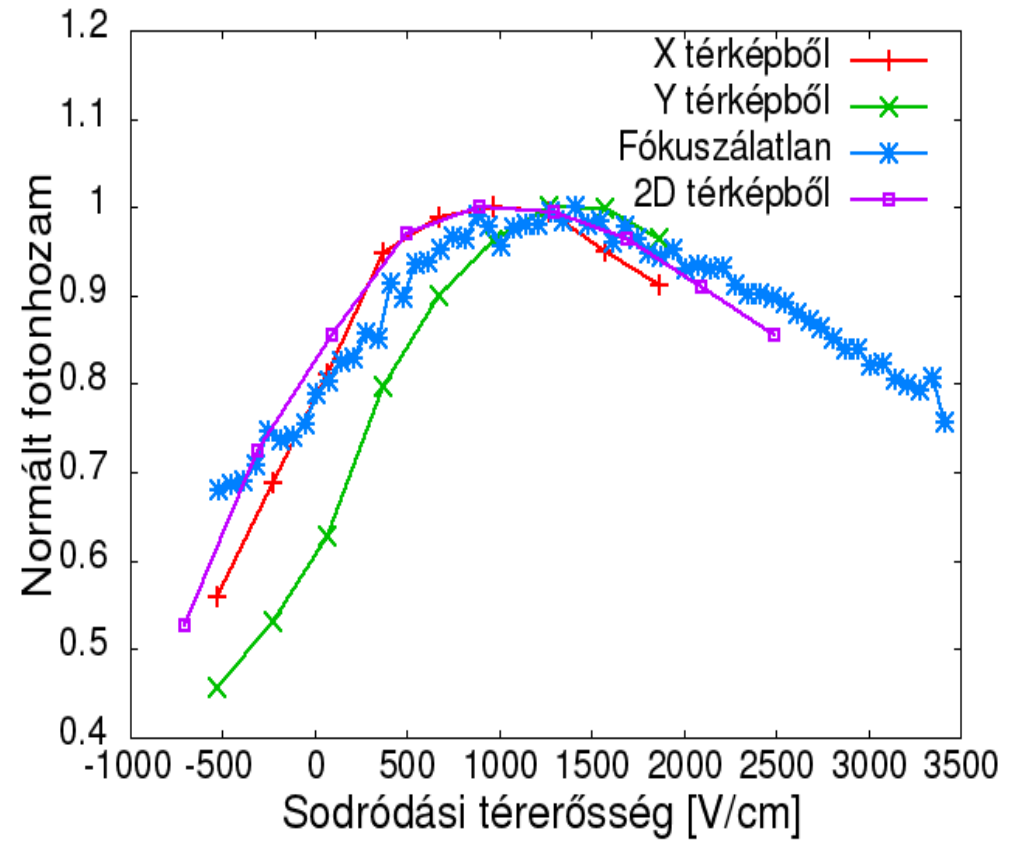
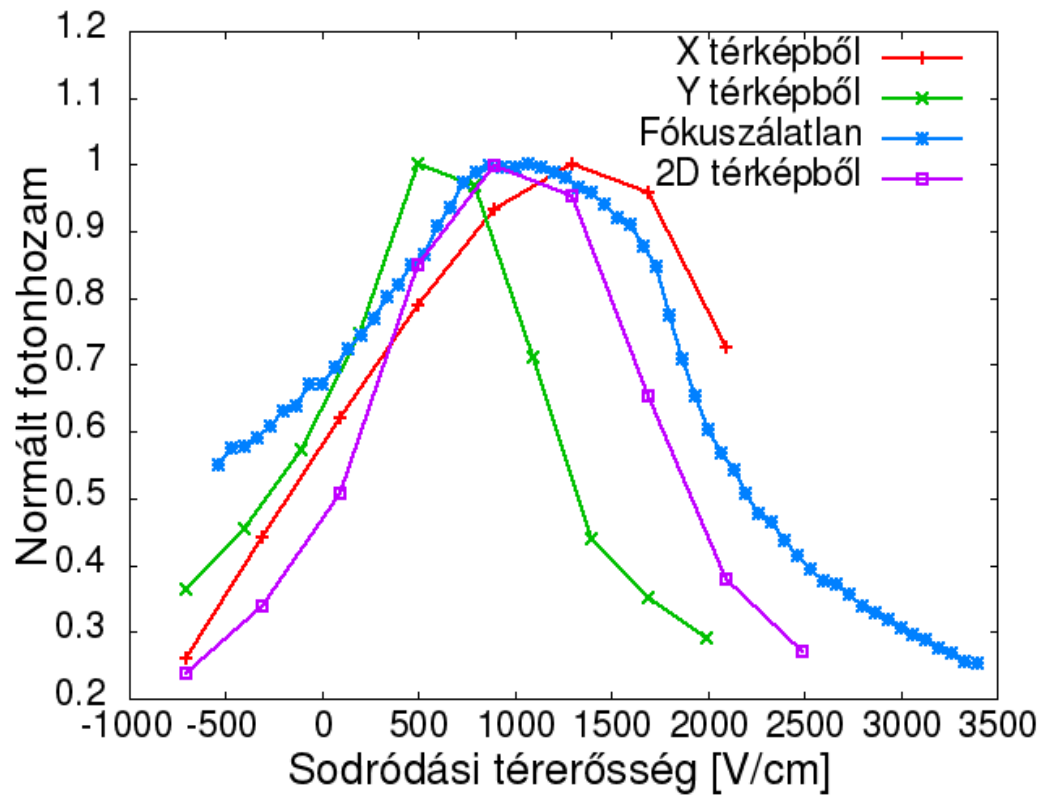


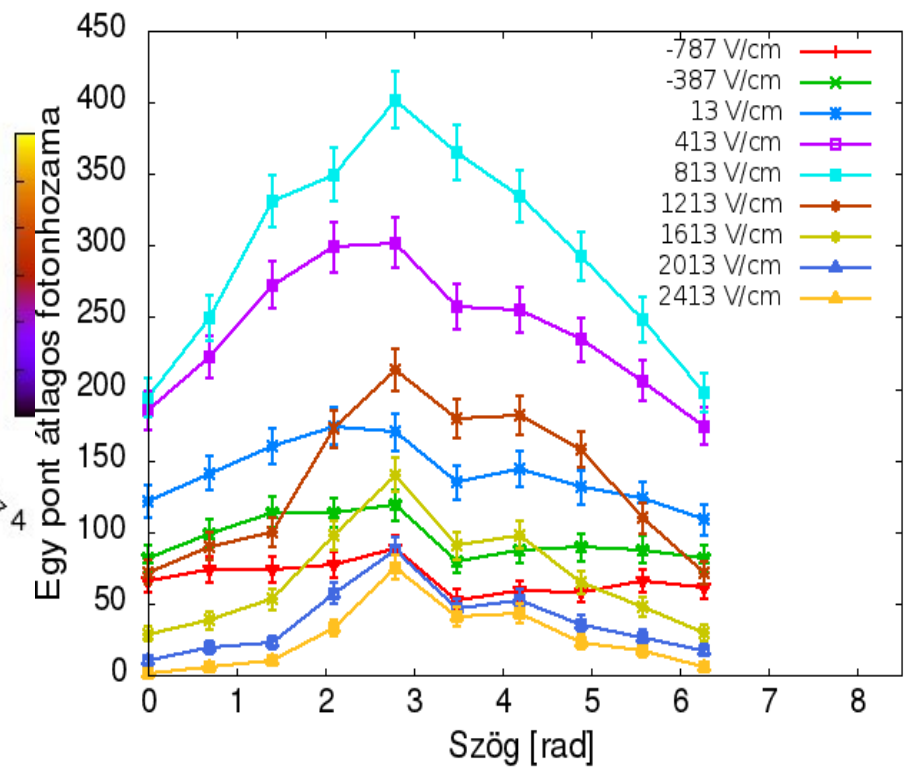
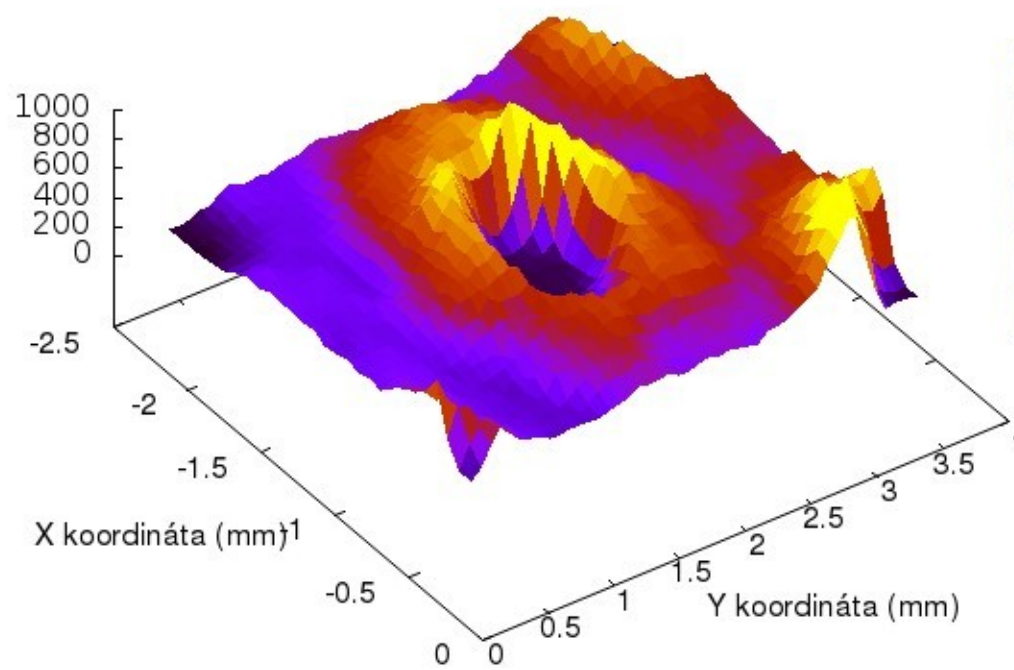




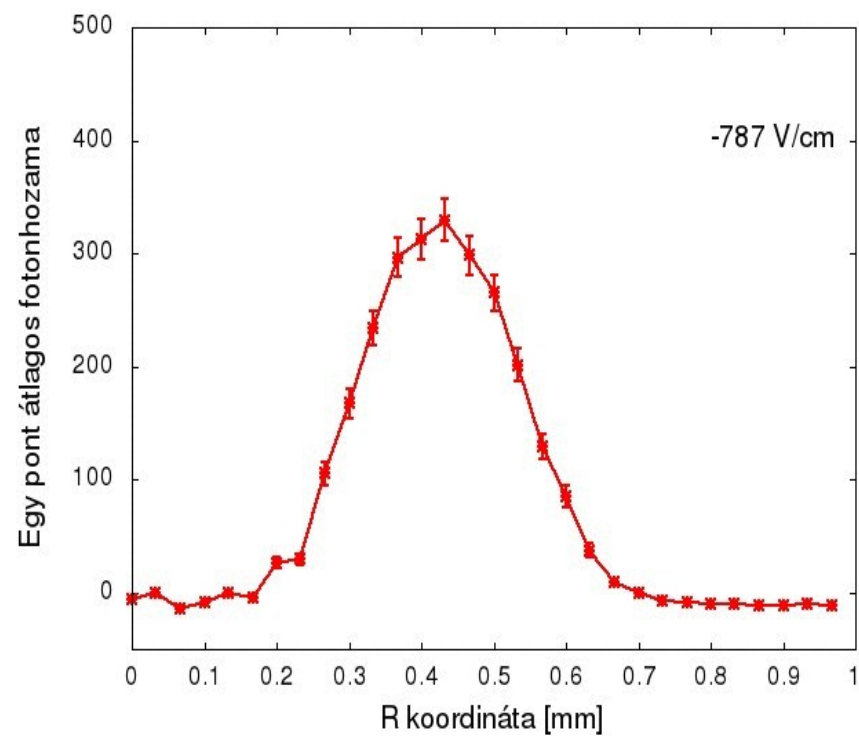
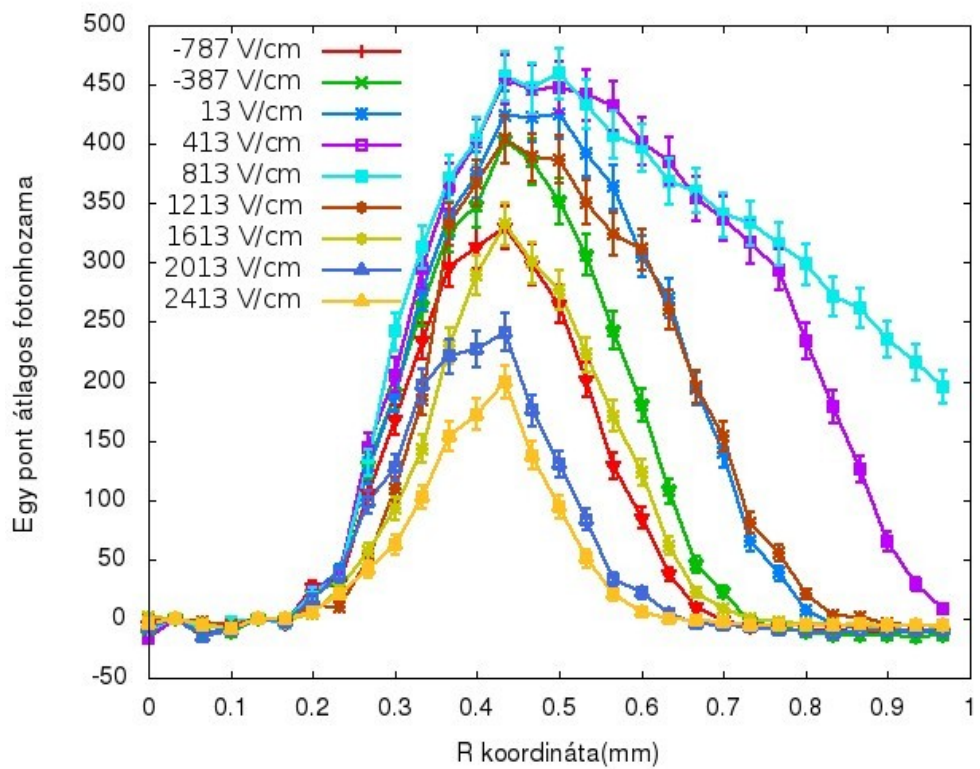
# Focus











# Optimal drift field

